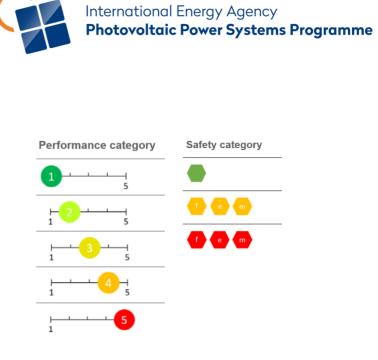
Component Defect	Module Front de	lamination						PVFS 1-3	
Appearance	the encap	Any local separation of the layers between (i) the front glass and the encapsulant or (ii) the cell and the encapsulant, visible as bubbles or as bright, milky area/s. It may appear continuous or in spots. The position and size of the delamination or bubble depends on the origin and progress of the failure.							
Detection	VI, (INS)	VI, (INS)							
Origin	many reas short lam glass, inc environm generally	The adhesion between the glass, encapsulant, active layers, and back layers can be compromised for many reasons. Typically, it is caused by the manufacturing process (e.g. poor cross linking of EVA, too short lamination times, too high pressure in the laminator, contaminations, improper cleaning of the glass, incompatibility of EVA with soldering flux, inadequate storage of the raw material) or environmental factors (e.g. thermal stresses, external mechanical stresses, UV). Delamination is generally followed by moisture ingress and corrosion. It is therefore more frequent and severe under hot and humid conditions.							
	Productio	n 🔲	Installation	n 🗌		Operation			
	electric ci performa the struct result in a current m power lo performa	a of the component an recuit and the edge du nee due to an increase ural integrity of the m additional optical refle- aismatch. If the misma ss. The inverter migh nee loss. Manufacturin within the same pro- nee.	e to possible of series resi odule. More ction and su tch is signifit also shut g related de	e water ingress. stance, affect long cover, delamination bsequent decreas cant, it will trigge down due to le lamination issues	Moist g tern on at se in er the akage ofter	ture in the mon in reliability and interfaces in to current. This controlled by bypass diode to current's lest in affects a rele	odule with the option of the o	rill decrease te cases also cal path wil he origin of nuse further or a further ercentage of	
	Safety:	● f c e		Performance:	1	2 3 4 5			
Mitigation	Corrective	Corrective actions		Preventive actions (recommended)		Preventive actions (optional)			
	Modules with a direct safety risk or a severity of 5 should be replaced. Regular inspections should be done to monitor the status of the not replaced modules. In case of individual module testing all modules which failed the insulation and/or wet-leakage test should be replaced.		Check validity of IEC 61215 certification and BOM, ground fault detection by inverter or other devices at all time.		Extended testing (e.g. da heat), pre-shipment insp (e.g. cross linking level o regular visual system inspections.		inspections el of EVA)		



Task 13 Performance, Operation and Reliability of Photovoltaic Systems



# PV Failure Fact Sheets (PVFS) 2023



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## 1 PV FAILURE FACT SHEETS (PVFS)

The PV failure fact sheets (PVFS, Annex 1) summarise some of the most important aspects of single failures. The target audience of these PVFSs are PV planners, installers, investors, independent experts and insurance companies, and anyone interested in a brief description of failures with examples, an estimation of risks and suggestions of how to intervene or prevent these failures.

The failure sheets do not aim to deepen the theoretical background of the failures and its detection, but they aim to summarise the key aspects described in the numerous IEA PVPS Task 13 technical reports [Herz22] [Köntges17] [Köntges14] [Schill21] [Jahn18] [Herrmann21] and reference documents [Sinclair17] [Packard12] [Eder19] [Moser17] [Yang19] [Walsh20] [Petter11] [India18] [India13] [Köntges16] [PVSurvey19] [DuPont20] used for the preparation of the PVFSs shown in Table 1. The failure sheets are specific to the component in which they occur.

#### 1.1 PVFS structure

The format of the PVFS is based on the failure description presented within the H2020 Solar Bankability project [SolBank20]. A rating system for the estimation of the severity of a failure is used here which simplifies the approach proposed within the IEA PVPS Task 13 [Köntges14] by implementing the rating system proposed by the Sinclairs [Sinclair17]. The correlation between the different failures is highlighted in the text by using bold characters. Each PVFS is structured into 1 to 3 pages. The first page is a descriptive page, whereas the remaining pages contain examples composed of a picture, a legend and an estimation about its severity. The first page is structured as follows:

#### Component

The PV system components are divided into:

- (1) PV module (including junction box)
- (2) Cables and interconnectors (at module, string and combiner box level)
- (3) Mounting (structure, clamps and screws)
- (4) Inverter

#### **Defect**

Short name describing the failure/defect.

## **Appearance**

Description of how the defect looks like.



**Table 1: List of PV Failure Fact Sheets.** 

No	Component	Failure name
1-1	PV module	Cell cracks
1-2	PV module	Discolouration of encapsulant or backsheet
1-3	PV module	Front delamination
1-4	PV module	Backsheet delamination
1-5	PV module	Backsheet cracking
1-6	PV module	Backsheet chalking (whitening)
1-7	PV module	Burn marks
1-8	PV module	Glass breakage
1-9	PV module	Cell interconnection failure
1-10	PV module	Potential induced degradation
1-11	PV module	Metallisation discolouration/corrosion
1-12	PV module	Glass corrosion or abrasion
1-13	PV module	Defect or detached junction box
1-14	PV module	Junction box interconnection failure
1-15	PV module	Missing or insufficient bypass diode protection
1-16	PV module	Not conform power rating
1-17	PV module	Light induced degradation in c-Si modules
1-18	PV module	Insulation failure
1-19	PV module	Hot spot (thermal patterns)
1-20	PV module	Soiling
2-1	Cable and Interconnector	DC connector mismatch
2-2	Cable and Interconnector	Defect DC connector/cable
2-3	Cable and Interconnector	Insulation failure
2-4	Cable and Interconnector	Thermal damage in combiner box
3-1	Mounting	Bad module clamping
3-2	Mounting	Inappropriate/defect mounting structure
3-3	Mounting	Module shading
4-1	Inverter	Overheating (temperature derating)
4-2	Inverter	Incorrect installation
4-3	Inverter	Complete failure (not operating)

The list does not pretend to be exhaustive or updated. The complete list with all PVFS can be downloaded under [PVFS21]



#### Detection

Description of methods which can be used to detect the failure. Detection methods in brackets lists secondary methods, which do not detect the failure with absolute certainty or which can be used in addition to other methods. Following abbreviations are used:

Table 2: Abbreviations of Detection Methods.

Abbreviation	Detection Methods
VI	Visual inspection
IRT	Infrared thermography
EL	Electroluminescence
IV	Daylight I-V measurement
UV	UV fluorescence
STM	Signal transmission method
MON	Data monitoring
dIV	Dark I-V measurement
BYT	Bypass diode testing
VOC	V <sub>oc</sub> measurement
INS	Insulation testing

## Origin

Description of the failure and its main causes and origin (1. Material and production, 2. Transport and installation, 3. Operation and maintenance).

### **Impact**

Description of the impact on the safety, performance and reliability of the component and system and its severity. For every failure, a range of possible ratings is given, one for the safety and one for the performance.

A failure is defined as a safety failure when it endangers somebody who is applying or working with PV modules or simply passing the PV modules. Three categories are defined in Figure 1.

Safety category	Description
	Failure has no effect on safety.
f e m	Failure may cause a fire (f), electrical shock (e) or a physical danger (m) if a follow-up failure and/or a second failure occurs.
f e m	Failure can directly cause a fire (f), electrical shock (e) or a physical danger (m).

Figure 1: Safety category



A failure is defined as a performance failure when it impacts the performance and/or reliability of a system. Five categories are defined in Figure 2. They go from 1 (low severity) to 5 (high severity).

Performance category	Description
1 5	The defect has no direct effect on performance.
1 5	The defect has a minor impact on performance.
1 3 5	The defect has a moderate impact on performance.
1 4 5	The defect has a high impact on performance.
1 5	The defect has a catastrophic impact on performance.

Figure 2: Performance category

For each category, the expected loss is estimated on the component level and if no mitigation measure is implemented. It can range from no power degradation (0%) over power degradation below detection limit (<2-3%), power degradation within warranty (<0.7-1%/year) and power degradation out warranty (>0.7-1%/year) to catastrophic power degradation (>3%/year).

#### **Mitigation**

Description of the corrective actions to be done on a short and medium term when detecting a failure and preventive actions to be implemented to avoid the failure from the beginning. Preventive actions are separated into recommended actions, representing the minimum requirement for small residential systems and optional actions for large scale systems.

The general rule for intervention in case of a failure is: All components with a direct safety risk or a performance severity of 5, highlighted in red, should be replaced or repaired. Regular inspections should be performed to monitor the status of the not replaced or repaired components.

## 1.2 Example PVFS: Front delamination

The delamination of the encapsulant **FS1-3: Front delamination** is here taken as example to further explain the FS structure and rating system.



C	NA - Jula								
Component	Module						PVFS		
Defect	Front delan	ination					1-3		
Appearance	Any local separation of the layers between (i) the front glass and the encapsulant or (ii) the cell and the encapsulant, visible as bubbles or as bright, milky area/s. It may appear continuous or in spots. The position and size of the delamination or bubble depends on the origin and progress of the failure.								
Detection	VI, (INS)								
Origin	The adhesion between the glass, encapsulant, active layers, and back layers can be compromised for many reasons. Typically, it is caused by the manufacturing process (e.g. poor cross linking of EVA, too short lamination times, too high pressure in the laminator, contaminations, improper cleaning of the glass, incompatibility of EVA with soldering flux, inadequate storage of the raw material) or environmental factors (e.g. thermal stresses, external mechanical stresses, UV). Delamination is generally followed by moisture ingress and <b>corrosion</b> . It is therefore more frequent and severe under hot and humid conditions.								
	Production		Installation	n 🗌		Operation			
Impact	Delamination or bubbles do not automatically pose a safety issue, but they can result in <b>red insulation</b> of the component and increased safety risk when they form a continuous path betwelectric circuit and the edge due to possible water ingress. Moisture in the module will deciperformance due to an increase of series resistance, affect long term reliability and in some cases the structural integrity of the module. Moreover, delamination at interfaces in the optical path result in additional optical reflection and subsequent decrease in current. This can be the originary to the mismatch. If the mismatch is significant, it will trigger the bypass diode and cause fur power loss. The inverter might also shut down due to leakage current's leading to a fur performance loss. Manufacturing related delamination issues often affects a relevant percental modules within the same production batch and consequentially has a big impact on syperformance.					th between vill decrease he cases also cal path will he origin of house further o a further ercentage of			
	Safety:	f e e		Performance:	1	2 3 4 5			
Mitigation	Corrective ac	tions	Preventive actions (recommended)		Preventive actions (optional)				
	Modules with a direct safety risk or a severity of 5 should be replaced. Regular inspections should be done to monitor the status of the not replaced modules. In case of individual module testing all modules which failed the insulation and/or wet-leakage test should be replaced.		Check validity of IEC 61215 certification and BOM, ground fault detection by inverter or other devices at all time.		Extended testing (e.g. dampheat), pre-shipment inspect (e.g. cross linking level of Exregular visual system inspections.				

Figure 3: First page of PVFS example with general information





Figure 4: Remaining pages of a PVFS contain examples composed of a picture, a legend and an estimation about its severity.

The first section of the sheet describes the **appearance** or how to recognise a specific failure and which **detection** methods are available. Delamination is generally easily detectable by visual inspection (VI) of the modules from the front. Insulation measurements (INS) can give a hint of a severe delamination, but it is not the first method to detect an early delamination, reason why it is put in brackets.

The second section describes the **origin** or in which phase of the lifetime of a PV system the failure occurs and what the main causes are. Delamination problems have its origin mainly in the quality of the raw material, the manufacturing process and/or the environmental factors to which the modules are exposed during its operational lifetime. Transport and installation do not generate any delamination problems.

The third section describes the **impact** the failure has on the safety and performance of the component and PV system. Below the general description the severity rating accord. Figure 1 and Figure 2 is given. The severity rating in the first page gives the full range of possible ratings observable in the field and how the failure can evolve over the whole lifetime of a PV system. The rating in the examples gives instead a snapshot of the gravity of the failure for a specific case at a certain time. The pictures are taken from literature or case studies and give only a partial picture of the situation and are here used to explain the potential levels of impact.

The delamination of the potting material does not automatically pose a **safety risk.** It is therefore often rated as not critical (see example 1.3.1-1.3.7, 1.3.10 and 13.11 in Annex 1), but depending on the propagation of the failure it can develop into a more severe safety failure.



When creating a continuous path between the electric circuit and the edge of the module (see example 1.3.13-1.3.15), delamination can lead to electric leakage currents with a direct risk of electrical shock or the risk can occur later, due to the progress of the delamination and/or the ingress of moisture. This is particularly the case when the original delamination is close to the edge of the module or the junction box, or if it is going over a very extended area (see example 1.3.8-1.3.12). The **performance loss risk** for modules with delamination problems ranges from 1 to 5. Very small delamination areas on top of a cell or outside the cell area and not combined with other failures, are classified as having no impact (1) or a minor power loss typically below the detection limit (2), if the failure is not increasing over time (see example 1.3.1-1.3.4, 1.3.8, 1.3.10 and 1.3.11). The severity is in the range of (2-4) when the delamination area is getting larger (see example 1.3.7 and 1.3.9) or if it is occurring in combination with follow-up failures like moisture ingress (see example 1.3.14) or an insulation failure (see example 1.3.13). It increases also when occurring in combination with a second failure like discoloration (yellowing or browning) of the encapsulant or backsheet (see example 1.3.6, 1.3.7, 1.3.13), or cell cracking (see example 1.3.5). A catastrophic performance loss of (5) is reached when the cell mismatch is so large that one or more bypass diodes could be activated (see example 1.3.13 and 1.3.14).

The last section describes the **mitigation** measures. In case of delamination, all modules which do not guarantee anymore the electrical safety or insulation resistance or have an active bypass diode, have to be replaced. Not replaced modules with minor delamination have to be monitored by regular visual inspections and ground fault detection. Basic preventive measures consist in selecting certified and tested products only. In case of large-scale systems regular system inspection is recommended.



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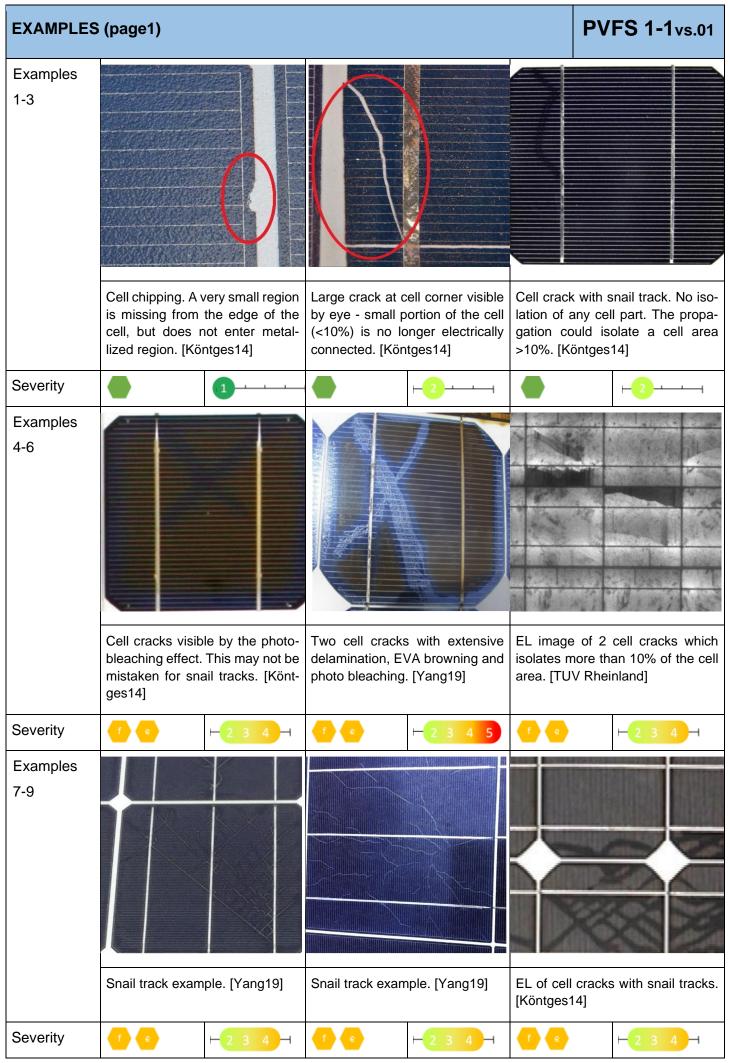
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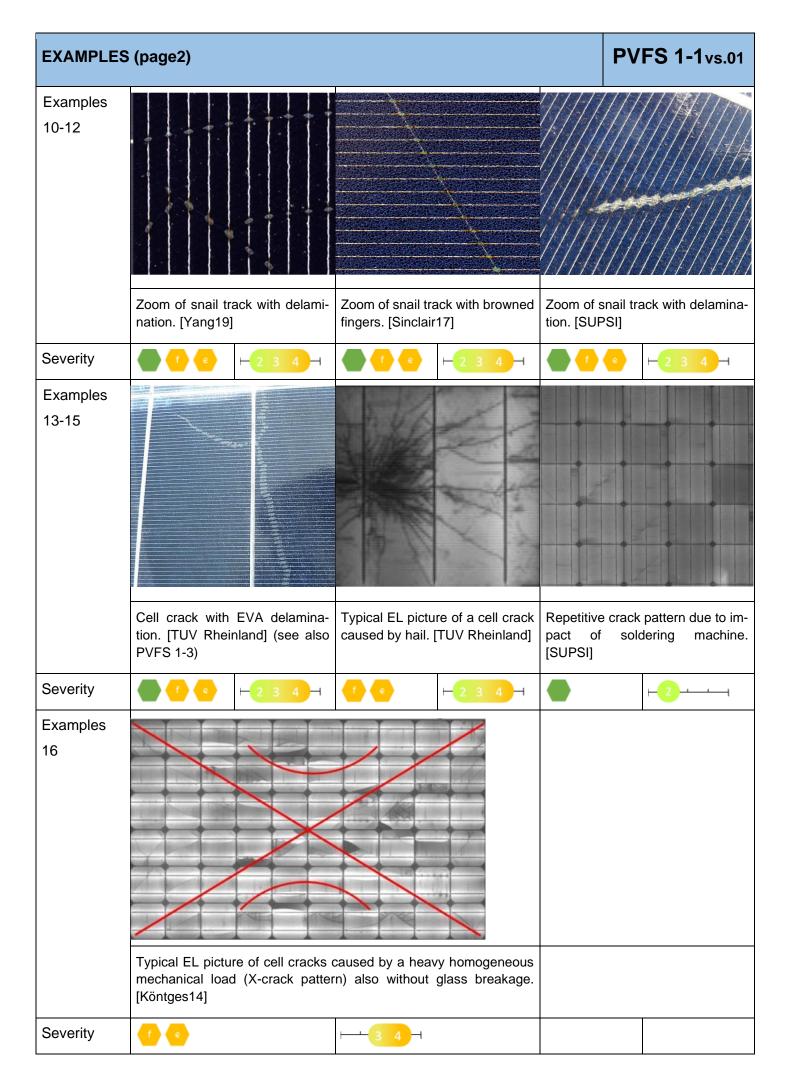
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# **ANNEX 1**

Component Defect	Module Cell crack	ks				PVFS 1-1vs.01			
Appearance	Cell cracks are cracks in the silicon substrate of the photovoltaic cells. Most of the cell cracks cannot be seen by the naked eye. Only large cracks or where the backsheet is visible through the cracks can be seen. Cell cracks can be easily detected through imaging techniques like electroluminescence, UV fluorescence or lock-in thermography. Cell cracks can have different lengths and orientations (crack patterns). Small cell cracks (micro-cracks) become visible by eye when they form <b>snail tracks</b> or when <b>photobleaching</b> or <b>delamination</b> takes place along the cracks. A snail track is a discoloration of the silver paste of the front metallisation of solar cells which occurs typically 3 months to 1 year after installation of the PV modules. Affected metal fingers on cells may be silver, yellow or brown in appearance, this effect can also be seen on cell edges. Photobleaching is a counteracting effect to the <b>yellowing</b> of the encapsulant and it occurs along the cracks and the borders of the cells. Delamination along cracks is visible as small bubbles.								
Detection	EL, UV (IR	T, VI ,IV)							
Origin	Cell cracks can have origin in all lifetime phases of a PV module: production, installation and operation. In production, cell cracks can occur during wafer, cell and module manufacturing. Especially the stringing and soldering process of the solar cells can damage the cells. After production, major sources for cell cracks are the packaging and transport of the modules, and the installation. After installation, external forces like hail, heavy snow weight or strong wind may result in cell cracks. Once cell cracks are present, further mechanical and thermomechanical stresses can lead to the propagation of the cracks into longer and wider cracks. Some crack patterns can give indications on the origin of the failure, but the final cause of cell breakage is not always easy to identify. A repetitive crack pattern can be for example caused by a production failure, whereas PV modules showing dendritic crack patterns have been probably exposed to heavy mechanical loads. Snail tracks can be found in a great variety of solar modules, but not in all. The combination of different materials (encapsulant and back sheets) with UV radiation and temperature plays an important role in the creation of snail tracks.								
	Production		Installatio	n 🔲	Operation	on 🔲			
Impact	Cell cracking does not necessarily lead to a failure of the module. The presence of a crack of any size that does not, or likely will not through its propagation, remove more than 10% of that cell's area from the electrical circuit can be considered to have limited to no impact on the performance. Even if each cell in a 60 cell module is cracked, but do not lead to a separated cell area, the power loss of the module is typically below 2.5 % of the nominal power. In cold and snow climate zones cell cracks seem to have a more pronounced impact. Here relatively high mean degradation rates of up to 7%/y can be found. Besides the risk of power loss there is a risk of hot spots and burn marks due to inactive cell parts. Snail tracks are reported to have no influence on the performance of the PV module, but due to the observed porous silver fingers the isolation of cracked cell parts may be accelerated more than it would be without snail tracks								
	Safety:			Performance:	1 2 3 4 5				
Mitigation	Corrective	actions	Preventive (recomme		Prevent (optional	ive actions II)			
	Modules with a direct safety risk or a severity of 5 should be replaced. Regular inspections should be done to monitor the status of the not replaced modules.		Adequate transport procedures, installation and cleaning by trained personal, in case of higher snow or hail risk use of therefore certified modules.		ean- duction, , in house if hail with mo during inspection	t EL pictures from pro- pre-shipment or ware- inspection, EL images bile laboratory before or installation, regular EL on or after sever conditions.			

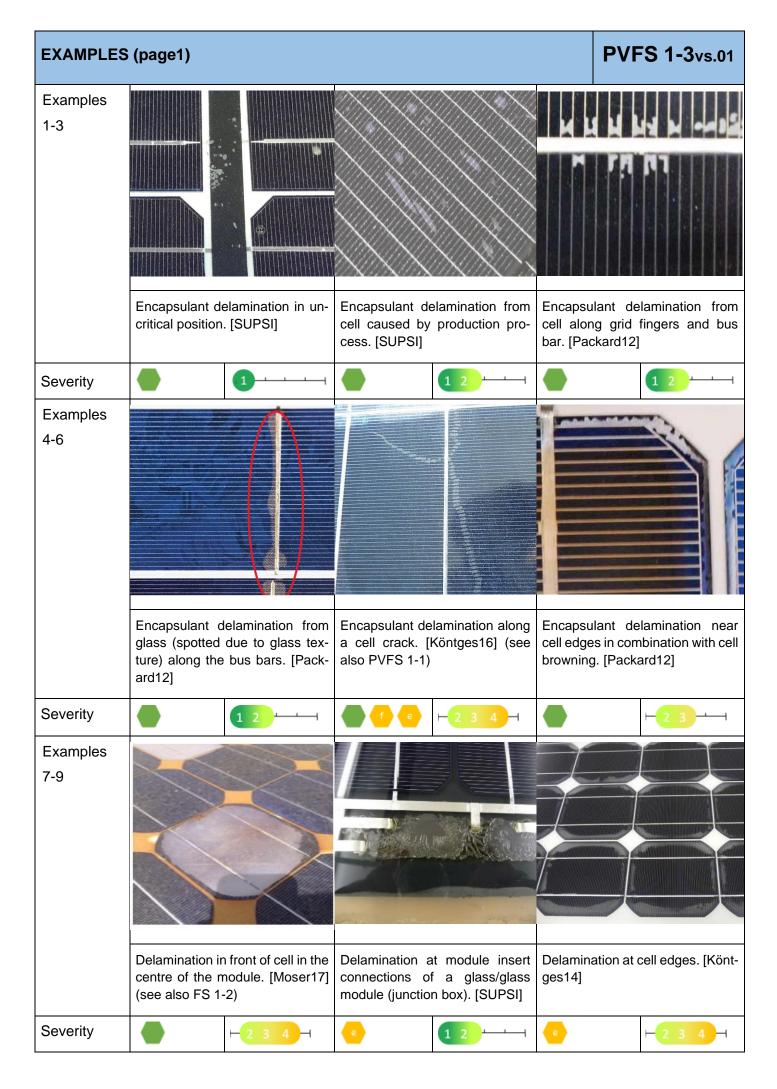


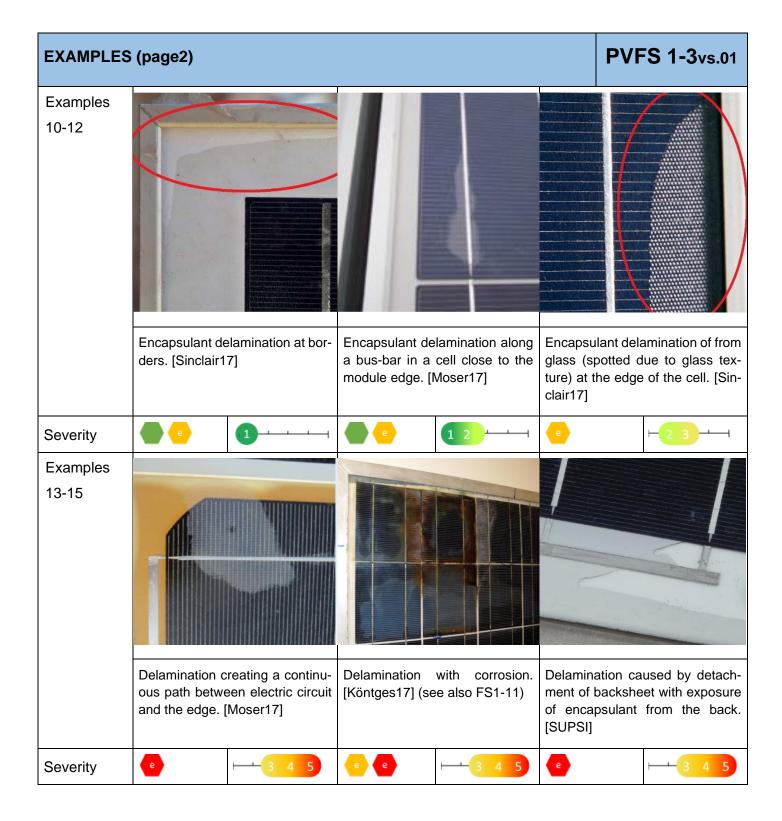


Component Defect	Module Discolouration of encapsu	PVFS 1-2vs.01							
Appearance	The degradation of the encapsulation or backsheet materials is getting visible as a light yellow to dark brown discolouration. Colour can be next to or above the cells, along the busbars or cell interconnects or on the back or front side of the backsheet. Often discolouration is inhomogeneous and follows spatial patterns depending on the type of module construction. Typically, for glass/backsheet modules the browning occurs in the central region of the cells with wide clear encapsulant areas, or "frames" around the cell edges. Discolouration can also be observed in the encapsulant between neighbouring solar cells when the front side of the backsheet (layer behind the cells) is degrading. For glass/glass module constructions the encapsulant discolouration is mostly spatially uniform, but can also show patterns of clearer areas over some cells. In glass/backsheet modules the location of these patterns generally correlates with <b>cell cracks</b> . In some cases, the discolouration is more pronounced in one or more cells of the module.								
Detection	VI, (IV, IRT)								
Origin	In the past, yellowing or browning was mostly associated with the degradation of the mostly used encapsulant ethylene vinyl acetate (EVA) but this problem was greatly solved by improved stabilisation of the polymer with additives, including UV absorbers and thermal stabilizers. If the choice of additives and/or their concentrations are inadequate, or the lamination process is inadequate or incomplete, the encapsulation material may discolour over time. The patterns of discolouration observed in the field can be very complex because of the diffusion of oxygen or the products of reaction, such as acetic acid, generated when heat and UV light interact with EVA. The presence of oxygen leads to the so called <b>photobleaching</b> effect which creates a ring of transparent EVA around the perimeter of a cell or a cell crack. The case of single cells which are far darker than the adjacent cells, implies that the most discoloured cell was at higher temperature than the surrounding cells, perhaps because of differences between the cells or the cell being located above the junction box.								
	Production	Installation	Operation						
Impact	Discoloration is a sign that the polymeric compounds within the module started to degrath type of degradation is predominantly considered to be first an aesthetic issue before decrease of module current and power production is detected. Typically, mean yearly dediction rates due to yellowing are about 0.5%/a and may reach up to 1%/a in hot and hum moderate climates. While it is uncommon for EVA discolouration to induce other failures we the cell, it may correlate to: high temperatures in the field, the generation of acetic acid concomitant <b>corrosion</b> and <b>embrittlement</b> . Unless discolouration is very severe and local at a single cell, where it could cause a substring bypass-diode to turn on, the discolouration EVA does not present any direct safety issues. More critical is the discolouration of UV set tive backsheets that can result in a loss of mechanical properties (elastic behaviour) <b>cracking of backsheet</b> due to thermomechanical stresses.								
	Safety:	Performance: 1	2 3						
Mitigation	Corrective actions	Preventive actions (recommended)	Preventive actions (optional)						
	Modules with a direct safety risk or a severity of 5 should be replaced. Regular inspections should be done to monitor the status of the not replaced modules.	Check validity of IEC 61215 certification and BOM.	Regular system inspections  For areas with harsh climate, request modules pass higher test standards, like double or triple IEC 61215 test condition.						

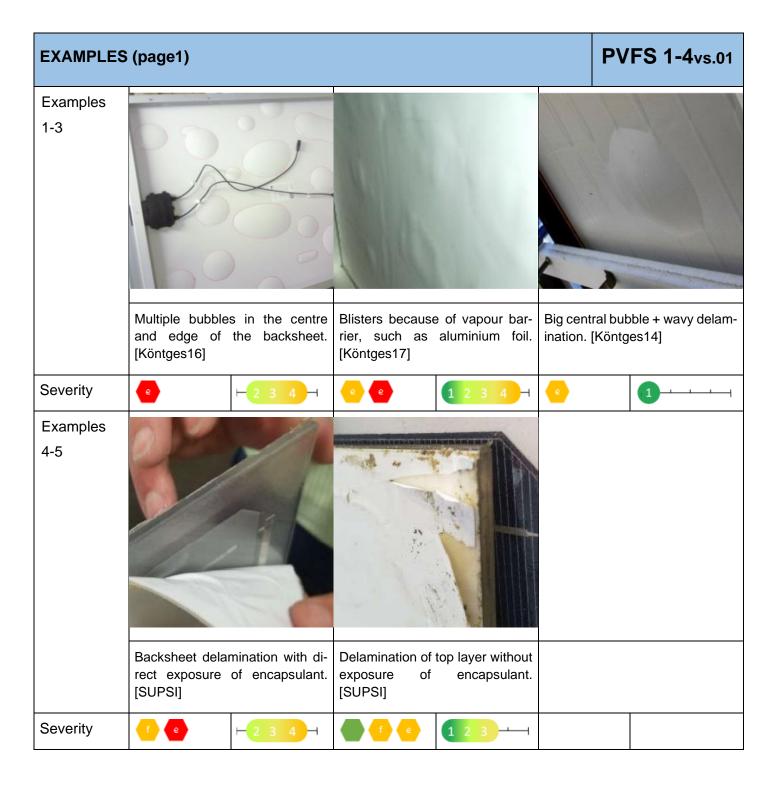
EXAMPLES	6 (page1)				PVF	S 1-2vs.01
Examples 1-3	nples					
		d EVA in the cen- h photobleaching öntges14]		d EVA in the cen- h photobleaching ndia18]	Yellowed backs side. [Sinclair17	heet from the in-
Severity		2		H2 3		1 2
Examples 4-6		tion at cell edges, nd over gridlines inclair17]	Dark discoloura zation. [Sinclair1		Backsheet air [Sinclair17]	side yellowing.
Severity		H 2 3 1		H2 3	e	1 2
Examples 7		rned much faster due to local heat-				
Severity	<b>●</b> (1) (2)	H2 3				

Component	Module						DV-50-4-6
Defect	Front delaminat	ion					PVFS 1-3vs.01
Appearance	Any local separation of the layers between (i) the front glass and the encapsulant or (ii) the cell and the encapsulant, visible as bubbles or as bright, milky area/s. It may appear continuous or in spots. The position and size of the delamination or bubble depends on the origin and progress of the failure.						
Detection	VI, (INS)						
Origin	The adhesion between the glass, encapsulant, active layers, and back layers can be compromised for many reasons. Typically, it is caused by the manufacturing process (e.g. poor cross linking of EVA, too short lamination times, too high pressure in the laminator, contaminations, improper cleaning of the glass, incompatibility of EVA with soldering flux, inadequate storage of the raw material) or environmental factors (e.g. thermal stresses, external mechanical stresses, UV). Delamination is generally followed by moisture ingress and <b>corrosion</b> . It is therefore more frequent and severe under hot and humid conditions.						
	Production		Installatio	n 🗌	(	Operation	on 🔲
Impact	Delamination or bubbles do not automatically pose a safety issue, but they can result in <b>reduced insulation</b> of the component and increased safety risk when they form a continuous path between electric circuit and the edge due to possible water ingress. Moisture in the module will decrease performance due to an increase of series resistance, affect long term reliability and in some cases also the structural integrity of the module. Moreover, delamination at interfaces in the optical path will result in additional optical reflection and subsequent decrease in current. This can be the origin of current mismatch. If the mismatch is significant, it will trigger the bypass diode and cause further power loss. The inverter might also shut down due to leakage current's leading to a further performance loss. Manufacturing related delamination issues often affects a relevant percentage of modules within the same production batch and consequentially has a big impact on system performance.						ney form a continuous a. Moisture in the mod- affect long term relia- eover, delamination at subsequent decrease th is significant, it will ht also shut down due g related delamination
	Safety:	<u>e</u> <u>e</u>		Performance:	1 2	3 4 5	
Mitigation	Corrective actions		Preventive (recomme			Preventive actions (optional)	
	Modules with a direct safety risk or a severity of 5 should be replaced. Regular inspections should be done to monitor the status of the not replaced modules. In case of individual module testing all modules which failed the insulation and/or wet-leakage test should be replaced.		Check validity of IEC 61215 certification and BOM, ground fault detection by inverter or other devices at all time.		ound ler or t	heat), pre-shipment inspe	

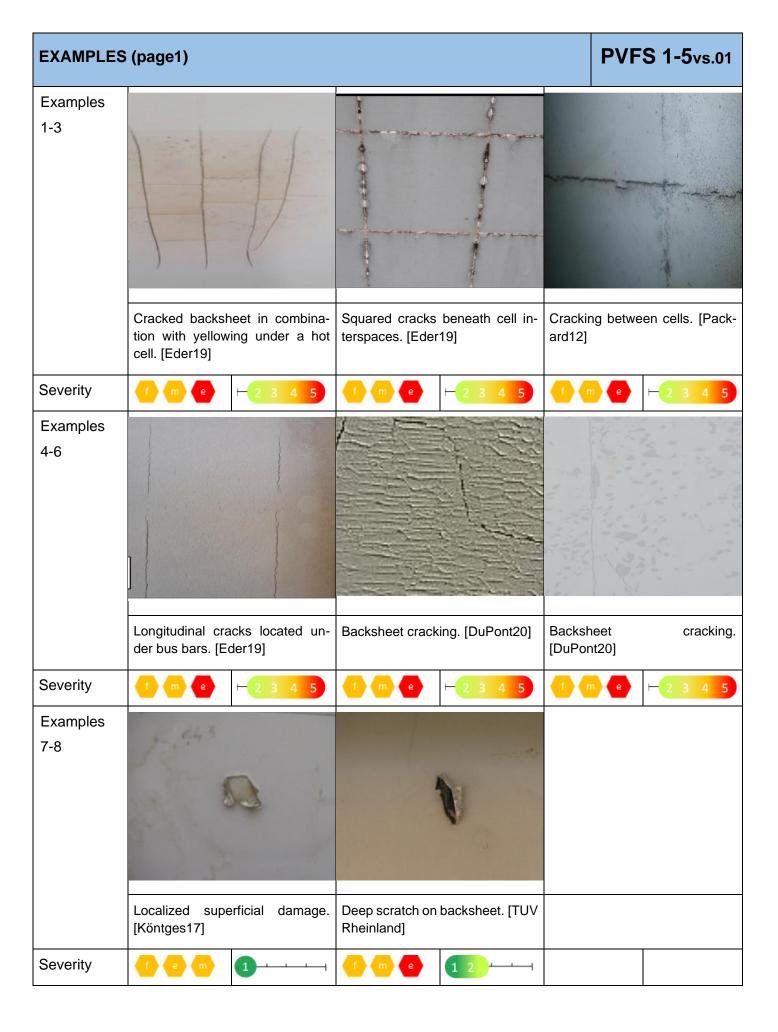




Component Defect	Module Backsheet de	P	VFS 1-4vs.01						
Appearance	backsheet and tion). The back worst case, one	Any local separation of the polymeric back sheet layers leading to an air gap between the backsheet and the rest of the module, or within the multilayer backsheet (=internal delamination). The backsheet may appear wavy, with locally limited bumps, bubbles or ripples. In the worst case, one or more layers may peel off. The position and extent of the delamination will depend on the cause and progression of the failure.							
Detection	VI, (INS)								
Origin	market. With land layer) internal of degradation, whome or more layed the backsheet from a lack of a street delamination differing Community and moisture frequent and see the layer.	There are many different forms and compositions of polymeric multilayer backsheets on the market. With laminated backsheets (polymeric layers adhered to each other by a thin adhesive layer) internal delamination can appear: the multiple layers may delaminate upon adhesive degradation, which may lead to local delamination of two subsequent layers or a peel-off of one or more layers. Co-extruded backsheet are prone to internal lamination. Delamination of the backsheet from the encapsulant can appear with all types of backsheets and originates rom a lack of adhesion between the backsheet and the encapsulation. The major drivers for the delamination of or within the the backsheet are (i) thermo-mechanical stress originating rom differing CTE of the individual polymeric layers, (ii) chemical reactions at the interfaces material incompatibility) or deteriorated interfacial bonding as a result of the attack from heat, JV and moisture or (iii) external mechanical stress applied on the module. Therefore, it is more requent and severe under hot and humid conditions. Delamination can be also caused by an insufficient lamination process e.g. too short lamination times.							
	Production	Production		Installation		Operation			
Impact  If delamination occurs forming bubbles in a central, open area of the back an immediate safety issue. That area would likely operate at slightly high the heat conduction/dissipation through the backsheet is disturbed. But as is not further mechanically cracked or expanded, the performance and s minimal. However, if delamination of the backsheet occurs near a junctice edge of a module there would be more serious safety concerns. Delamination provide a direct pathway for liquid water to enter the module during a rainst to the presence of dew. That can provide a direct electrical pathway to groserious safety concern. Similarly, delamination near a junction box can concern putting mechanical stress on live components with the danger of breakancause a connection failure to a bypass diode and possibly result in an unsystem voltage. In multilayer backsheets the severity depends also on which						ghtly highed and But as a junction Delamination a rainstovay to group of breakatin an unr	er temperatures as long as the bubble afety concerns are in box, or near the on at the edge may orm, or in response and creating a very ause its loosening, ge. A break might mitigated arc at full		
	Safety:	f e e	Performance: 12		1 2	2 3 4 -			
Mitigation	Corrective action	ons	Preventive (recomme			Preventive optional)	actions		
	Modules with a direct safety risk or a severity of 5 should be replaced. Regular inspections should be done to monitor the status of the not replaced modules. In case of individual module testing all modules which failed the insulation and/or wet-leakage test should be replaced.		Check validity of IEC 61215 certification and BOM.  Ground fault detection by inverter or other devices at all time.		y in-	Regular sys	stem inspections.		



Component Defect	Module Backsheet cracking  PVFS 1-5vs.01						
Appearance	Any damage of the backsheet (surface or whole stack) that is visible as crack, burst or scratch. The location and extent of the cracks depend on the cause and progression of the failure. The cracked area may be localized (e.g bursted bubble, scratch), extend along specific module areas (e.g. long or between the cells, along the busbars) or extend over large or the full area of the module (e.g embrittled surface). The crack can be very deep and affect the back sheet stack.						
Detection	VI, (INS)						
Origin	The degradation of the backsheet can be caused by environmental factors like UV-irradiation, thermal stress, external mechanical stress or by internal stress (e.g. thermomechanical stress with the multimaterial composite PV-module) or incorrect handling during transport and installation (local cuts, scratches). Deep backsheet cracking (whole backsheet stack split) is often followed by moisture ingress and <b>corrosion</b> . This is more frequent and severe under hot and humid conditions. The use of low quality material (e.g. low UV resistance) or incompatible material combinations (backsheet ↔ encapsulant) causes most of the premature degradation failures. <b>Discolouration</b> and or strong <b>chalking</b> can be precursors for backsheet cracking. Deep cracks or bursted bubbles can be the result of local <b>hotspots/burn marks</b> that split or break the backsheet.						
	Production	Installation	Operation				
Impact	potential ground fault. On the lo into the module which induces	ong-term, power degradation du further failures (e.g. corrosion, the active part of the cells, the	posing a safety hazard and a le to the penetration of moisture delamination) can occur. In the insulation is immediately com-				
	Safety:	Performance: 1	2 3 4 5				
Mitigation	Corrective actions	Preventive actions (recommended)	Preventive actions (optional)				
	Modules with a direct safety risk or a severity of 5 should be replaced. Regular inspections should be done to monitor the status of the not replaced modules. In case of individual module testing all modules which failed the insulation and/or wet-leakage test should be replaced.	Ground fault detection by inverter or other devices at all time, check validity of IEC 61215 certification and BOM, visual inspection before installation.					



Component Defect	Module Backsheet chalking (whitening)  PVFS 1-6vs.01					
Appearance	White powder is detectable on the external surface of the backsheet. It can be seen by passing a finger over the backsheet. It can be removed. The backsheet has usually a rough or dull appearance.					
Detection	VI					
Origin	Chalking is caused by the photothermal degradation of the polymers in the outer backsheet layer containing inorganic pigments. For example, TiO <sub>2</sub> pigments are often used in the outer layers as UV blocker.					
	Production	Installatio	Installation		tion	
Impact	Chalking does not affect module safety or performance on first sight, but it can be a sign for an ongoing degradation of the backsheet and a precursor for severe backsheet cracking. Due to the degradation-induced reduction of UV protection, more serious failures, such as <b>backsheet cracking</b> and <b>insulation failures can occur</b> . Enhanced moisture diffusion into the encapsulant/active PV-parts can lead to <b>corrosion</b> of cells and connectors, having a negative impact also on the performance.					
	Safety:		Performance:	1	<u></u>	
Mitigation	Corrective actions Preventive actions (recommended)			Prever (option	ntive actions (al)	
	Regular inspections should be done to monitor the pro- gress of the observed failure. Ground fault detection by in- verter or other devices at all time.	certification	alidity of IEC 61 on and BOM.	215 Regula	ar system inspections.	

EXAMPLES	(page1)		PVFS 1-6vs.01
Examples 1-2			
	Finger with white powder. [TUV Rheinland]	Fingerprint on a module with chalking. [TUV Rheinland]	
Severity	<b>1</b>	<b>1</b>	

Component	Module				DV	FO 4 7	
Defect	Burn marks	FS 1-7vs.01					
Appearance	Burn marks are visible with the naked eye as burnt, blackened area/s. The burn mark may lead to bubbling or melting of the polymeric encapsulant, and/or glass breakage or a hole in the backsheet. Burn marks on the backheet may be not visible from the front requiring an inspection with an IR camera if the back of the module is not accessible. They may however not be visible by IR inspection in case no further or ongoing heating occurs.						
Detection	VI, IRT, (EL)						
Origin	The defect is associated with parts of the module that became very hot because of production errors (e.g weak solder bonds, ribbon breakage, incomplete cell edge isolation, alignment errors, metal particles) and/or transportation/handling errors (e.g, <b>cracked cells, damaged back-sheet</b> ) in combination with one or more operational factors (e.g. shadowing, <b>open circuited bypass diodes</b> , reverse current flows). Physical stress during PV module transportation, heavy snow loads, a lightning strike, thermal cycling, and/or <b>hot spots</b> by partial cell shading during long-term PV system operation forces mechanical weak(ended) cell/connection parts to break. Burn marks occur for example when a reverse current flow causes heating that further localizes the current flow, leading to a thermal runaway effect and the associated burn mark.						
	Production	Installatio	n 🔲	Оре	ration		
Impact	Burn marks on interconnections are often associated with power loss, but if redundant electrical interconnections are provided, a failed solder bond may have negligible effect on the power output. If all solder bonds for one cell break, then the current flow in that string is completely blocked and an electric arc can result if the current cannot be bypassed by the bypass diode and the system operates at high voltage. Performance, reliability and safety are likely to be severely compromised. Such an arc can cause a fire if there happen to be flammable material around. If there is a question about whether the existence of the burn mark requires replacement of the module, an infrared image under illuminated and/or partially shaded conditions will quickly identify whether the area is continuing to be hot and/or whether current flow has stopped in that part of the circuit. Temperature difference between neighbouring cells should not be over 30 K. At this stage safety risk may still be not so high because the temperature of this hot spot cell does not increase to more than around 100 °C. Also edge <b>isolation faults</b> on the solar cell level are under normal conditions not problematic, but when the bypass diode is in open-circuit, the current is driven in reverse through the shunts of the solar cells and burns the encapsulation.						
	Safety: f e m f e	Performance: 1 2 3 4 5					
Mitigation	Corrective actions Preventive actions (recommended) Preventive actions (optional)					actions	
	Modules with a direct safety risk or a severity of 5 should be replaced. Regular inspections should be done to monitor the status of the not replaced modules.	stallation, commissioning of system with IRT.				tem inspections.	

# **PVFS 1-7vs.01 EXAMPLES** (page1) Examples 1-3 Burn mark at the backsheet with Burn marks at the backsheet due Burn mark associated with overto heating along a busbar. [Köntheating along the metallic intercracked backsheet. [Sinclair17] ges14] connection (without back-sheet damage). [Köntges14] Severity Examples 4-6 Front and back side view of burn marks caused by open-circuited by-Burn marks caused by defect pass diodes and current mismatch conditions (due to shading or bypass diodes or an interconnect failure in the junc. box. cracked cells). [Köntges14] [Köntges14] Severity Examples 7-9 Burn mark with broken glass Burn mark due to intrinsic shunt-Burn mark due to intrinsic caused by poor bussing ribbon ing caused by error in manufacshunting caused by error in soldering. [Yang19] (s. also PVFS turing process. [Yang19] manufacturing process. 1-8 and PVFS 1-8) [Yang19]

Severity	f e n	3 4	5	f e	m	1 2 3		f e	m	1 2 3
Component Defect	Module Glass breakage  PVFS 1-8vs.01							S 1-8vs.01		
Appearance	depending treated flo	Glass is cracked locally or over the full area of the module. Glass breakage looks different depending on the type of glass and the origin of the glass breakage. Tempered glass or heat-treated float glass will shatter into small pieces, whereas annealed glass breaks into big pieces. Heat-treated glass stays in between.								
Detection	VI, IRT									
Origin	Glass breakages of the front glass can be caused by heavy impacts such as hail or stones or other extreme mechanical stress onto the module frame due to external stresses or bad mounting. High temperatures (hot-spot or arc) can also break the glass. Annealed glass breaks also due thermal gradients or stress induced by the lamination process or cleaning of the modules. A relatively often seen failure in the field is glass breakage of frameless PV modules caused by the clamps. Glass/glass modules are more sensitive to glass breakage. The origin of the failure is, on the one hand, at the planning and installation stage either (a) poor clamp geometry for the module, e.g. sharp edges, (b) too short and too narrow clamps or (c) the positions, kind or number of the clamps on the module not being chosen in accordance with the manufacturer's manual. The second origin which induces glass breakage could be excessively-tightened screws during the mounting phase or badly-positioned clamps. The glass of some PV modules may also break due to vibrations and shocks occurring during transportation or handling. Another reason for glass breakage comes from impact stresses on the glass edge. Sometimes vandalism or animal damage happens, the animals like goats like to climb on the PV modules, and birds may drop stone or other objects from the sky.									
	Production			Installatio	n 🔲			Operation	on 🗏	
Impact	Module mechanical integrity is compromised when the glass is broken. Over time glass breakage leads to loss of performance due to cell and electrical circuit corrosion caused by the penetration of oxygen and water vapour into the PV module. Shattering of tempered glass usually also breaks the cells reducing the power of the module and increasing the risk of hot spots. Mechanical and electrical safety is thus compromised. Firstly, the insulation of the modules is no longer guaranteed, in particular in wet conditions. Secondly, glass breakage causes hot spots, which lead to overheating of the module. A module with a completely broken glass lead to current and power reductions in the whole string.									
	Safety:	f e m	f	e m	Perf	ormance:	1 2	2 3 4 5	5	
Mitigation	Corrective actions Preventive actions (recommended) Preventive actions (optional)						ons			
	All damag to be repla	ed modules ha	ave	Adequate transport procedures, installation and cleaning by trained personal, in case of higher snow or hail loads use of certified modules.  Regular system inspection Regular system Regular sys				n inspections.		

# **PVFS 1-8vs.01 EXAMPLES** (page1) Examples 1-3 Chipped glass at the corner. Glass breakage along the string Glass breakage of tempered [Packard12] interconnect ribbons due to weak glass induced by a hot-spot. manufacturing process. [SUPSI] [SUPSI] Severity Examples 4-6 Glass breakage caused by too Glass breakage caused due to Glass breakage caused due to tight screws. [Köntges14] (see poor clamp design. [Köntges17] poor clamp design. [Köntges14] also PVFS 3-1) (see also PVFS 3-1) Severity Examples 7-9 Breakage of tempered glass. Glass breakage through high Glass breakage of tempered temperature gradient and not glass induced by burn mark. [Köntges17] [Köntges17] (see also PVFS 1-7 tempered glass. [Köntges14] and PVFS 1-9) Severity

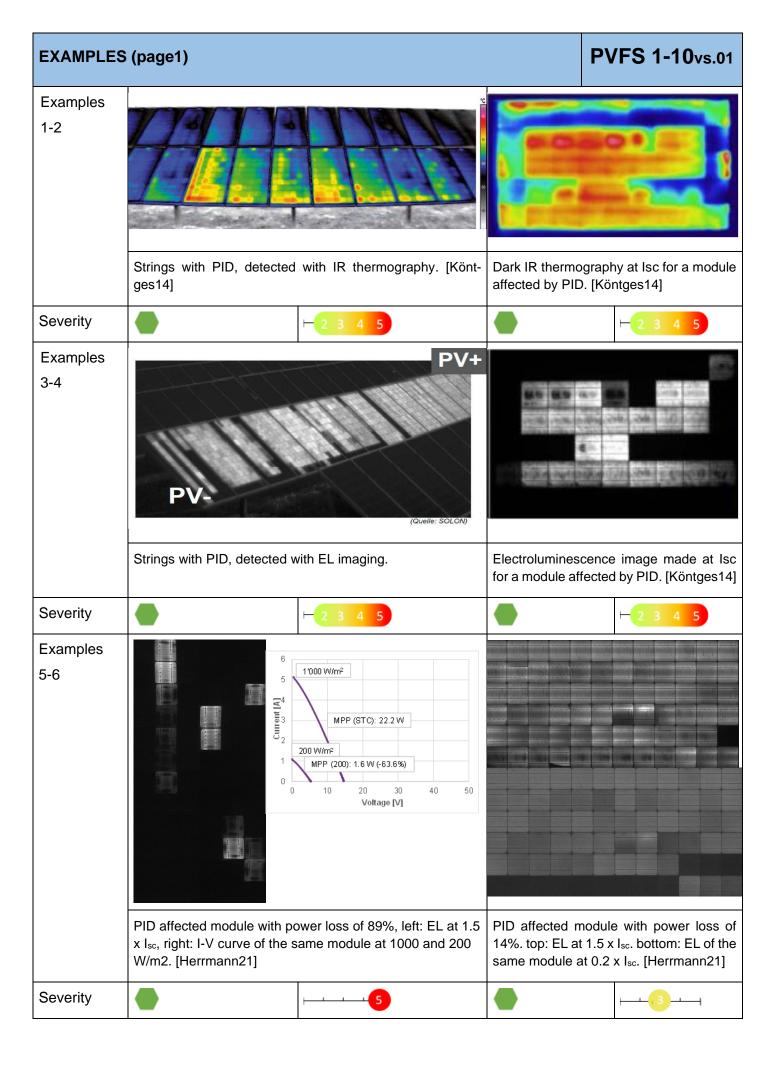
EXAMPLES	(page2)		PVFS 1-8vs.01
Examples 10-12			
	Direct lightning stroke. [Könt-ges16]	Impact damage caused by a Hail da heavy object. [SUPSI]	ımage. [SUPSI]
Severity	f e m		e m  5

Component	Module PVFS 1-9vs.01							
Defect	Cell interconnection failur	е	1 VI O 1-3VS.01					
Appearance	can be identified as dark region nect would otherwise be collected.	Weak or broken cell or string interconnection are not easy to see by the naked eye. The failure can be identified as dark region in the electroluminescence image where the failed interconnect would otherwise be collecting carriers or as a <b>hot spot</b> in the infrared image. In a progressed stage <b>burn marks</b> and <b>glass breakage</b> can occur.						
Detection	EL, IRT, STM, (VI)	EL, IRT, STM, (VI)						
Origin	Typically, it is caused by the manufacturing process (e.g. poor soldering, misplacement of ribbons, too intense deformation of the ribbon kink, narrow distance between the cells) followed by thermomechanical stress or repetitive wind load caused by the outdoor operating environment. <b>Electrochemical corrosion</b> can be another cause for the degradation of interconnections.							
	Production	Installation	Operation					
Impact	Poor interconnections (soldering bonds) lead to an increase of contact resistance, higher power dissipation and localized heating. Broken connections are often associated with power loss, but if redundant electrical interconnections are available, a failed connection may have negligible effect on the power output. Safety risk may be not so high until the temperature of the induced <b>hot spot</b> does not increase to more than around 100 °C. If all busbars of a cell are interrupted, then the current flow in that string is completely blocked and an electric arc can result if the current is not bypassed by the bypass diode and the system operates at high voltage. The safety risk depends on the durability of this bypass diode. A bypass diode, which is continuously active over days can be damaged and pass into open-circuit or short circuit state. As a result of an <b>open circuited diode</b> , the current goes through the failed cell string and generates heat at the disconnected position. Very high temperatures or an electric arc and may cause fire, open electrical conducting parts to the user and destroy the mechanical integrity of the module.							
	Safety:	Performance:	2 3 4 5					
Mitigation	Corrective actions Preventive actions (recom- preventive actions tional)							
	Modules with a direct safety risk or a severity of 5 should be replaced. Regular inspections should be done to monitor the status of the not replaced modules.  Check validity of IEC 61215 certification and BOM.  Regular system in certification and BOM.							

EXAMPLES	6 (page1)				PVI	FS 1-9vs.01
Examples 1-3	Zoom of a brok	xen cell intercon-	Disconnected detected		Disconnected	cell interconnect
	nect. [Yang19]	terr cen intercerr	_	ed inter-connect		on. [Köntges17]
Severity	f e	2 3 4	f e	<b>⊢</b> 2 3 4 <b>⊣</b>	fe	<b>⊢234 ⊣</b>
Examples 4-6						
	Dislocation of ribbon. [Sinclain	interconnection 17]	connect leading	of string inter- to burn mark and ang19] (see also VFS 1-8)	ductive glue or	n occur if the con- n the string inter- n insufficient con- 4]
Severity	f e	1 2	f e m	3 4 5	fe	H2 3 4 H

Component	Module						
Defect		Il induced degrada	ation (PID)	) (page1)		PVFS 1-10vs.01	
Appearance	A potential induced degradation (PID) is not directly visible by eye. It is recognisable as an overtime increasing power loss, which is easily observable only a few years after installation. Infrared thermography (IRT) imaging of operational PV modules in the direct sunlight is the most straightforward method for getting the evidence of PID degradation. Typical PID IRT patterns (warmer cells close to the bottom frame or patchwork patterns) and PV modules positioned close to one of the poles of the module string are strong indications for PID. The most efficient, but more complex and expensive detection method for PID is to take EL images. When taken at 1/10 of the rated current it can detect PID also in an early stage, before a power loss can be noticed. It's because in the early stage, the PID degradation is more pronounced at low light conditions. To quantify the performance loss, I-V measurements have to be performed on the affected string and/or modules. In an advanced stage secondary induced failures like hot-spot's, yellowing and/or corrosion can be sometimes observed.						
Detection	IV, EL, IR	RT, (MON)					
Origin	PID is a degradation mode induced by a high voltage stress with respect to ground. The occurrence of this failure depends on the magnitude of the voltage (number of serially connected PV modules per string) and the polarity of the electrical field build-up between the framing/glass surface and the solar cells. The last depends on the inverter typology (transformer), the grounding concept and cell technology. Modules with p-type cells degrade in negative polarity strings whereas modules with n-type cells in strings with positive polarity. PID degradation is more pronounced the higher the potential to which a single cell within a module or string is subjected. The PID effect is therefore stronger in cells that are located at the edges of the module (close to frame) and to the bottom of a string with an increase towards one end of the string. The degradation is further accelerated by temperature, humidity, rain (surface wetting), condensation and soiling. Two different types of PID are known for crystalline silicon modules: PID-p (polarization) and PID-s (shunting). The PID-p was observed for the first time in back contact cells within Sunpower modules. PID-p is caused by the build-up of negative surface charges on the cells, which results in a current loss. The PID-s is induced by leakage currents through the module's front glass and the encapsulation material. The flow of Na+ ions mainly from the glass into the cell leads to the creations of shunts. For both PID types, module and cell design has a fundamental influence if and how much a module is affected by PID. There are modules on the market which are designed to be PID resistant.						
	Production	on 🔲	Installatio	n 🔲	Opera	ation	
Impact	Yield losses of 20 percent and more within 1 year were observed in the past. The PID-s effect causes a reduction of I-V curve fill factor and output power. Short circuit is affected only in a very progressed state. Due to its catastrophic performance loss PID-s bears a high economic risk. PID-s is to some extent a reversible polarization effect and can therefore 'repaired' or omitted when detected in time. If detected too late the PV system can't be repaired and non-reversible damages has to be taken into account. The PID-p effect causes instead a significant reduction of short circuit current, open circuit voltage and power. PID-p can be fully regenerated by reversing the polarity of the bias potential. Up to now safety problems directly related to the PID are not reported, but hot spots and corrosion caused by the strong cell mismatch may cause later safety issues. The PID sensitivity of PV modules can be tested in the laboratory. Anti-PID insurance can be obtained, although many insurers need to be educated about the phenomenon for correct risk estimation and pricing.						
	Safety:			Performance:	<b>□</b> 2 3 4	5	

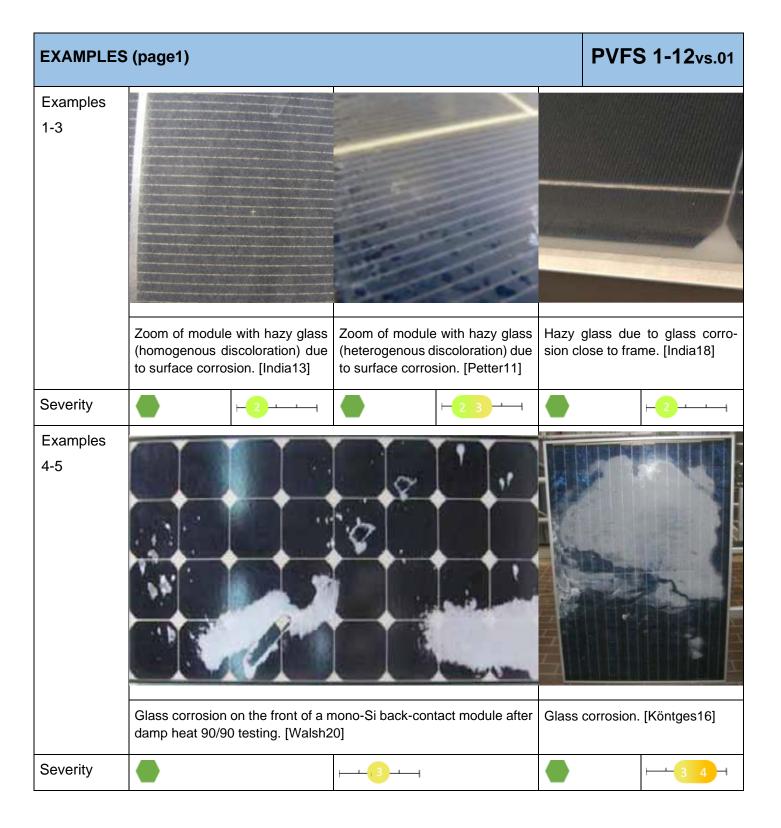
Component Defect	Module Potential induced degrada	PVFS 1-10vs.01	
Mitigation	Corrective actions	Preventive actions (recommended)	Preventive actions (optional)
	How to proceed depends very much on the stage on which PID is detected. If detected in an early stage recovery is possible by applying a reverse voltage during night-time. Specific anti PID kits are available on the market promising a recovery of the lost power. As there is not a full guarantee that the recovery will be effective for the specific situation, it should be monitored or measured to see if the problem has been sufficiently solved. In the case of progressed PID without visible module damages, the recovery could need several months or even years suggesting in any case a replacement of all modules with modules tested to be PID resistant.	Modules tested for PID accord. IEC 62804-1 should be less prone to PID (verify that BOM corresponds!)	PID prevention at system level: The installation of an inverter with transformer can be considered as mitigation measure for the PID phenomenon. On the other hand, the trade-off with the inverter efficiency and the cost of the inverter must be taken into account. Anti-PID insurance.



Component Defect	Module Metallisa	ation discolouratio	on/corros	ion		PVFS 1-11vs.01
Appearance	visible as on the ma products tinge. Th cell/string laminatic certain cirof the EL	a light yellow to dark aterial combinations of that may appear power defect occurs typic interconnect ribbons on and discolouration reumstances corrosion images can here highne gaps between the	brown to be corrosion is wdery, white cally at the cally at the call of the end of the distribution is more valight the distribution.	lack discolourating furthermore not be, light gray, are solder bonds, often observed acapsulant and strisible near cell effusion of moisture.	on of the ticeable and/or har on the together cometime edges. Do not the together cometime edges.	e interconnections is getting e electrical parts. Depending by the presence of galvanic ve a yellow, blue, or greer cell gridlines/fingers or the with other failures like dees with burn marks. Undeark areas at the cell borders igh the rear side of the mode cell corrosion starting from
Detection	VI, (EL, I	<b>V</b> )				
Origin	in the end EVA or re- lisation are process I can be can lamination sion resist and/or ere monia, san under hot be also re-	capsulant, as e.g. ace emaining crosslinker ( and the cell interconner eads together with the aused by a poor man an process; imperfection tance of tin-based concapsulant materials). It, humidity, temperate and humid climates	tic acid, a peroxides) ct. The ingree oxygen to ufacturing ons in cell stating of continue). For the or in agriculture,	degradation produced. Acetic acid has ress of moisture to a further acceprocess (e.g respoldering) or the apper ribbons, hiental factors can be reasons, coulture or maritim	duct of the caused eleration sidual cruckoice of the caused market elements of the caused market elements of the caused elements of the c	ence of moisture and acidity the mostly used encapsulant sive effect on the cell metal by an ongoing delamination of the corrosion. Corrosion osslinker due to a too short poor materials (low corrost permeability of back sheet are the corrosion (e.g am is more frequent and severe the series of the corrosion can due to light-sensitive soldes.
	Production	n 🔲	Installatio	n 🗌	Op	peration
Impact	therefore metallisat issue. Lo	losses in module per ion discolouration with cally increased series	formance. hout corros resistance	The power loss sion. The defect leads to current	is less p does not mismato	eased series resistance and ronounced for modules with automatically pose a safety ch. If the mismatch is getting or loss of the PV module.
	Safety:	<u> </u>		Performance:	1 2 3	4 5
Mitigation	Corrective	e action	Preventive (recomme			reventive actions ptional)
	Modules with a direct safety risk or a severity of 5 should be replaced. Regular inspections should be done to monitor the status of the not replaced modules.		Check validity of IEC 61215 certification and BOM.		1215 Re	egular system inspections.

EXAMPLES	6 (page1)		PVFS 1-11vs.01
Examples 1-3		- A (a	
	Discolouration due to corrosion or to light-sensitive flux residues on the ribbon.	Discolouration due to corrosion on the ribbon. [SUPSI]	String interconnect corrosion. [Köntges17]
Severity	•	1	12
Examples 4-6			
	Cell interconnect corrosion. [Köntges17]	Modules with light Ag finger oxidation after 5 years in the field. [Yang19]	Severe oxidation/corrosion and burn marks on the Ag fingers, busbars, and interconnects of modules after 25 years. [Yang19]
Severity	12	-2	€ ⊢2 3 4 ⊢
Examples 7-9			
	Corrosion seen as red, green and black discolouration in the string interconnect. [Yang19]	Busbar corrosion and delamination at the edge. [SUPSI]	Glass/glass module showing de- lamination and subsequent cor- rosion. [Köntges17]
Severity	e e	e 3 4 5	e e

Component Defect	Module Glass corrosion or abras	Module Glass corrosion or abrasion  PVFS 1-12vs.01							
Appearance	The degradation of the glass front layer is getting visible as a homogenous or heterogeneous change in colour and transparency of the glass. The affected glass surface can appear hazy or milky and in some cases also rougher compared to the non-degraded module/module area. Increased susceptibility to soling could be observed.								
Detection	VI, (IV)								
Origin	To optimise the efficiency and appearance of a PV module most manufacturers apply some anti-reflective coatings (ARC), anti-soiling coatings (ASC) or multilayer coatings on the front of their modules. 1-3% more power can be obtained by these techniques respect to module with uncoated glass. Corrosion or abrasion of these layers can however, reduce or vanish the effectiveness of these coatings. Glass corrosion is caused by atmospheric humidity in combination with gases or particles present in the atmosphere (e.g. pollutants, salt, ammonia) and the glass. It happens for example when water (dew) dissolves some of the sodium ions from the top of the soda lime glass, leading to the production of an alkali base that can then corrode the glass silicate. Glass abrasion or corrosion can be also caused by inappropriate cleaning techniques (mechanical removal techniques, inappropriate cleaning agents) which damage or removes the coatings. Abrasion occurs mostly in the desert, due to the combination of wind, sand and dust which causes abrasion and frosting of the glass surface.  UV or voltage induced degradation effects can further accelerate the degradation of the coatings.								
	Production	Installation	on 🗌	Opera	ation				
Impact	Corrosion or abrasion of the a power loss. The power loss except in the case where the can be observed. Operating	s is generally soiling sus	y limited to a few ceptibility is signi	percent an ficantly incr	id is saturating over time reased and larger losses				
	Safety:		Performance:	<b>⊢</b> 2 3 4	Н				
Mitigation	Corrective actions	Preventiv (recomm	re actions ended)	Preve (optio	entive actions onal)				
Modules with a direct safety risk or a severity of 5 should be replaced. Depends on the level of performance loss. For extreme environments (e.g. near to mines, cement factories), evaluate cost-effectiveness of replacing modules with lost yield.				pro- on in	lar system inspections.				



Component Defect	Module Defect or detached junction box  PVFS 1-13vs.01									
Appearance	melted or burned) and/or deta backsheet). The sealant/adhes sheet can be weathered or app	The junction box housing and lid appears either defect (weathered, brittle, cracked, warped, melted or burned) and/or detached (open or loose lid, shifted or detached junction box from backsheet). The sealant/adhesive material with which the junction box is attached to the backsheet can be weathered or appear as yellowed. The sealing components/material around the wire entrance or the lid can be damaged (squeezed, broken, brittle) or completely missing.								
Detection	VI									
Origin	of low quality adhesive. Acrylic terial in early years, but they f tachment. Use of inadequate II failure. Opened or badly close sure caused by high temperature box can cause it to become loce the cause of damages the j-be missing cable fixing or usage of	Junction box detachment results from poor fixing of the junction box to the backsheet or use of low quality adhesive. Acrylic or PE Foam tapes were used as junction box attachment material in early years, but they frequently loss stickiness at low temperature and result in detachment. Use of inadequate IP rating junction box may cause water intrusion and subsequent failure. Opened or badly closed j-boxes may due to poor manufacturing process or air pressure caused by high temperature for boxes with no exhaust path. Delamination near a junction box can cause it to become loose. Improper handling or mounting of the modules can be also the cause of damages the j-box, like pulling modules up on the cables before mounting, or missing cable fixing or usage of too short cabling to interconnect modules to a string, causing frequent or permanent mechanical stress on the j-boxes.								
	Production	Installatio	n 🔲	Opera	ation					
Impact	A defect or detached junction be nections, leading to performan quent initiation of fire. Further contacts within the junction box electrical components.	nce losses nore, a loc	and increasing risk on se junction box is pu	of elect utting m	rical <b>arcing</b> and subsenechanical stress on the					
	Safety: f e f e		Performance:	(	1 2 3 4 5					
Mitigation	Corrective actions	Preventiv (recomm		Preve (optio	ntive actions nal)					
	Modules with a direct safety risk or a severity of 5 should be replaced or repaired. Regular inspections should be done to monitor the status of the not replaced modules.	certification	heck validity of IEC 61215 ertification and BOM. round fault detection by inerter or other devices at all me.		ar system inspections.					

# **PVFS 1-13**vs.01 **EXAMPLES** (page1) Examples 1-3 Poorly bonded junction box on Open junction box in the field. Detached junction box from the backsheet. [Köntges14] backsheet. [SUPSI] [Yang19] Severity Examples 4-5 Left: Missing junction box lid sealing with corrosion of contacts. Missing seal or strain relive of Right: Good junction box sealing. [India13] module cables, improper cable inlet. [Sinclair17] Severity 1 2 3 4 5 Examples 6-7 Melted junction box. [TUV Rhein-Burned junction box caused by corroded contacts within the land] junction box. [TUV Rheinland] Severity

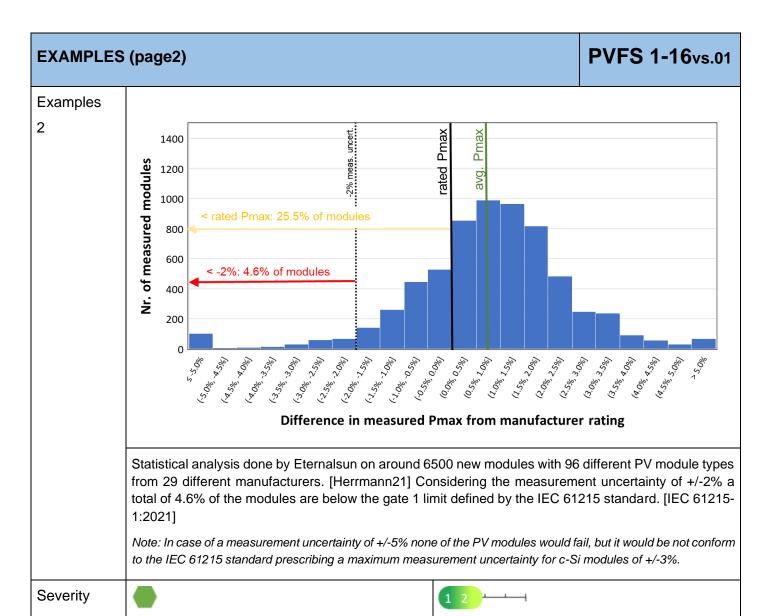
Component Defect	Module Junction box interconnection failure  PVFS 1-14vs.01									
Appearance	involve solder joints, wires, by could be hidden by the potting potting material. The materia	Not connected, broken, burned, corroded or short circuited parts within the junction box. It can involve solder joints, wires, bypass diodes or tabbing ribbons. The interconnection failure itself could be hidden by the potting material in the junction box and be visible only by removing the potting material. The material can appear as degraded (yellowed, browned, burned or bubbled) due to the heat or arcing occurring in the junction box.								
Detection	IRT, (VI, IV, VOC)									
Origin	box. Contacts are either sold soldering contacts are cause residuals of the previous prod caused by loose clamping or cycling of day and night and s boxes (e.g. adhesion loss, brit ing) leads to corrosion of the	Bad contacts or moisture ingress may be the cause of interconnection failures in the junction box. Contacts are either soldered, screwed or inserted (mechanical spring clamping). Bad soldering contacts are caused by low soldering temperature (cold solder point) or chemical residuals of the previous production process on the solder joints. Bad mechanical contacts are caused by loose clamping or screws. Mechanical contacts can get loose due to the thermal cycling of day and night and seasonal changes. Moisture ingress in bad or damaged junction boxes (e.g. adhesion loss, brittled, cracked, missing seal at wire entrance or junction box housing) leads to corrosion of the contacts. Delamination near the junction box and breaking boxes.								
	Production	Installatio	n 🗌	Opera	ation 🔲					
Impact	Bad contacts or <b>corrosion</b> carbox. Resistive heating can encpasulant/backsheet behin worst case interconnection far The heat can be detected with failures can also lead to significate of a module or a string. The matress conditions. Interconnectinitiate fire.	moreover of and arou illures caus the a IR car icant power easuremen	result in <b>discoloura</b> nd the junction box a es a short circuit or in the nera. In addition to the losses, which can be affected by compare the can be affected by compare the second se	tion a and to nternal he visu detect changin	nd burn marks in the glass breakage. In the arcing within the j-box. all defects, interconnect ted by measuring the V <sub>oc</sub> ag mechanical or thermal					
	Safety:		Performance:		1 2 3 4 5					
Mitigation	Corrective actions	Preventiv (recomm		Preventive actions (optional)						
	Modules with a direct safety risk or a severity of 5 should be replaced. Regular inspections should be done to monitor the status of the not replaced modules.	Ground f	Check validity of IEC 61215 certification and BOM.  Ground fault detection by inverter or other devices at all time.		ng of modules with mo- est centre before installa- regular system inspec- nstallation of arc detec- pol.					

### **PVFS 1-14vs.01 EXAMPLES** (page1) Examples 1-3 Junction box with poor wiring. Detached tabbing ribbon due to Corrosion failure due to water [Köntges14] bad soldering. [Köntges14] soaking of the IP65 rated Jbox. [Yang19] Severity Examples 4-6 Jbox failure due to poor electric Evidence of loose screw connec-Cold soldering of module busconnection. [Yang19] tion inside Jbox with browning of sing ribbon to the Jbox connection terminal pad with minor pottant. [Yang19] browning of pottant. [Yang19] Severity Examples 7-9 Overheating due to the poor Jbox Overheating due to the poor Jbox IR imaging of a hotspot Jbox due interconnect leading to light disinterconnect to loose electric connection inleading to burn coloration and burn mark on front mark and glass breakage. side. [Yang19] and back side. [Yang19] [Yang19] Severity

Component Defect	Module Missing or insufficient bypass diode protection  PVFS 1-15vs.01									
Appearance	Missing, d	Missing, disconnected, inverted, damaged, open circuited or short circuited bypass diode.								
Detection	BYT, (IV, I	RT, EL, STM)								
Origin	voltages d the diodes working co are used a discharges open circu shortened to high vol diode is sii	ypass diodes fail either because they are undersized or because they are exposed to high oltages due to lightning strikes or other high voltage events. In addition to these two reasons, in e diodes have a certain ppm of failure rate, that is the nature of the component. For diodes orking constantly at high temperatures this failure rate increases. Typically, Schottky diodes are used as bypass diodes in PV modules, but they are very susceptible to static high voltage scharges and mechanical stress. Two main failure modes are observed with bypass diodes: ben circuit or short circuit. Short circuit condition occurs when the bypass diode is physical nortened in the junction box, it is mounted the wrong way around or when it has been exposed high voltages like lightning strikes or static electricity. Open circuit condition occurs when a ode is simply missing, it is not properly connected, a strong current damaged the diode, or it undersized and not resisting to a continuous current flow.								
	Production	n 🔲	Installatio	n 🗌	Оре	ration $\square$				
Impact	module ar verse bias through th for the cell case, fire. these risks module bu point. Byps heat dissip	odes are mainly used to avoid the reversion of the solar of the solar of the bypass diode and and may evolve how the problem is that also of other moduless diode failures so pated in the junction issues like leakage of the solar of the sol	se biasing cells. In the a cell can less that the failure pass diodes within its metimes country.	of single solar case of an open be reversed with t may cause brown will be not detect will continuously string by causing ause the junction be the junction be	ells highe circuited a higher wning, but ted until by lower the gashift colors.	r than the allodiode no curre voltage than it urn marks or, the module is e power prod ff of their max eform or even	ent is flowing t is designed in the worst s exposed to luction of the simum power burnt due to			
	Safety:	1		Performance:	1 2 3	4 5				
Mitigation	Corrective	actions	Preventive actions (recommended)			entive actions onal)	s			
	risk or a s be replace tions shou	with a direct safety everity of 5 should ed. Regular inspec- ld be done to moni- atus of the not re- dules.	Check by sioning, system w	•	of ode	ing of modules with mobile re installation inspections.	test centre			

Component Defect	Module Not conform power rating	PVFS 1-16vs.0							
Appearance	The STC output power of a brand new module is below a specified tolerance limit or the minimum nameplate output power is not clearly specified by the manufacturer.								
Detection	IV, (MON)								
Origin	pends on the product variability ment uncertainty. The quality of applied in production for the reproduct variability. The deviat sources of uncertainty, for exact ature, calibration of the solar site equipment, connectors and call has to take into account any test 17). This means that after a first to be within the rated power to performing the STC performant have to be stabilised according specific test requirements are pending on the technology, a new reification of power ratings. For	Deviations of the measured power of a single module respect to the name plate power depends on the product variability, manufacturing quality, the labelling policy and the measurement uncertainty. The quality of cells (e.g. LID susceptibility) together with the binning method applied in production for the reduction of mismatch losses, has a significant impact on the product variability. The deviations in the measurement in the factory comes from several sources of uncertainty, for example the environment temperature, measured module temperature, calibration of the solar simulation, maintenance of the reference module, measurement equipment, connectors and cables. According to the international standards, the power rating has to take into account any technology related initial degradation effects (for c-Si see FS 1-17). This means that after a first exposure to light the output power of a new module has still to be within the rated power tolerance. The measurement uncertainty of the test laboratory performing the STC performance test has therefore to be taken into account. The modules have to be stabilised according the procedure described in IEC 61215-2:2021. Technology specific test requirements are described in IEC 61215-1-1:2021 to IEC 61215-1-4:2021. Depending on the technology, a maximum allowable measurement uncertainty is defined for the verification of power ratings. For c-Si modules it is specified as 3%. A PV module is considered to be conform to the IEC61215 standard, when following criterion (gate 1) is fulfilled:							
	P <sub>max</sub> (Lab) ·	$\left(1 + \frac{\frac{1.65}{2}  m_1 [\%]}{100}\right) \ge P_{\text{max}}(N)$	NP) $\cdot \left(1 - \frac{1}{2}\right)$	$\frac{t_1 [\%]}{100}$					
	$P_{max}$ (Lab): measured maximum STC $P_{max}$ (NP): minimum rated nameplate	power of each module in stabilize to power of each module without ra		on tolerances					
	m <sub>1</sub> : measurement uncertainty	$\gamma$ in % of laboratory for $P_{max}$ (expan	nded combine	ed uncertainty (k = 2)					
	_	er production tolerance in % for Pn							
	The minimum nameplate power nameplate or data sheet value the nameplate value, the modustated on the nameplate or the value on the nameplate or dauncertainty components are specific power.	es. If the $P_{max}(NP)$ derived frule can be considered to be datasheet, then $t_1 = 0$ . If the ta sheet (for example, if mu	om the da not conform tolerance is ultiple toler	tasheet is different from m. If the tolerance is not s not reduced to a single rances or measurement					
	Production	Installation	Opera	ation $\square$					
Impact	A non-conform STC power rations and investor expectations	tive impact on the lifetime er alled STC power has a direct	nergy yield	and financial return. An					
	Safety:	Performance:	1 2 3	_					
Mitigation	Corrective actions	Preventive actions (recommended)	Preve (option	ntive actions nal)					
	Confirm underperformance through an accredited PV test laboratory. Claim for missing power.	Verify power warranties and data sheet conformity, purchase modules from trusted and/		endent third party test- samples at factory gate r arrival on site. Signa- of a contractual agree-					

EXAMPLE	S (page1)			PVFS 1-16vs.01
Examples				
1	a)	$\begin{array}{c c} \textbf{Product Z300W} \\ \hline \text{Maximum power } (P_{\text{max}}) & 300 \text{ W} \\ \pm 3 \text{ \%} \\ \hline \text{Maximum power voltage } (V_{mp}) & 37 \text{ V} \\ \hline \text{Maximum power current } (I_{mp}) & 8,1 \text{ A} \\ \hline \text{Open circuit voltage}^a (V_{oc}) & 45,9 \text{ V} \\ \hline \text{Short circuit current}^a (I_{sc}) & 8,9 \text{ A} \\ \hline \text{Maximum DC system voltage} & 1 000 \text{ V} \\ \hline ^a +5 \text{ \% } \textit{I} -0 \text{ \% tolerance} \\ \hline \end{array}$	$\begin{array}{c cccc} \textbf{Product Z series} \\ \textbf{\textit{Electrical Data at STC} \\ \hline \textbf{Peak power watts $\pm 3\% - P_{\max}(W) & 300 & 305} \\ \hline \textbf{Maximum power voltage - $V_{mp}(V)$ & 37 & 37,2} \\ \hline \textbf{Maximum power current}(I_{ng})(A) & 8,1 & 8,2 \\ \hline \textbf{Open circuit voltage}^a - V_{oc}(V) & 45,9 & 45,9 \\ \hline \textbf{Short circuit current}^a - I_{sc}(A) & 8,9 & 8,92 \\ \hline \textbf{Module efficiency - $\eta_m$}(\%) & 14 & 14,2 \\ \hline ^a \pm 5\% / -0\% \text{ tolerance on $I_{sc}$ and $V_{oc}$} \\ \hline \end{array}$	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$
	b)	$\begin{array}{c c} \textbf{Product X300W} \\ \hline \text{Maximum power } (P_{\text{max}}) & 296 \text{ to} \\ 300 \text{ W} \\ \hline \text{Maximum power voltage } (V_{mp}) & 37 \text{ V} \\ \hline \text{Maximum power current } (I_{mp}) & 8,1 \text{ A} \\ \hline \text{Open circuit voltage}^a (V_{\infty}) & 45,9 \text{ V} \\ \hline \text{Short circuit current}^a (I_{sc}) & 8,9 \text{ A} \\ \hline \text{Maximum DC system voltage} & 1 000 \text{ V} \\ \hline ^a \pm 4 \text{ \% production tolerance} \\ \hline \end{array}$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	306 to 310 $V_{\rm oc}$ (NP) = 296 W; $t_1$ = 0 % $V_{\rm oc}$ (NP) = 45,9 V; $t_2$ = 4 % $V_{\rm sc}$ (NP) = 8,9 A; $t_3$ = 4 % 8,98 14,4
	с)	$\begin{array}{c c} \textbf{Product Y300W} \\ \hline \text{Maximum power } (P_{\text{max}}) & 300 \text{ W} \\ \pm 3 \text{ \% } / - 0 \\ \hline \text{Maximum power voltage } (V_{mp}) & 37 \text{ V} \\ \hline \text{Maximum power current } (I_{mp}) & 8,1 \text{ A} \\ \hline \text{Open circuit voltage } ^{ab} (V_{oc}) & 45,9 \text{ V} \\ \hline \text{Short circuit current } ^{ab} (I_{sc}) & 8,9 \text{ A} \\ \hline \text{Maximum DC system voltage} & 1 000 \text{ V} \\ ^{a} \pm 2 \text{ \% measurement uncertainty} \\ ^{b} \pm 10 \text{ \% tolerance on } I_{sc} \text{ and } V_{oc} \\ \hline \end{array}$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	00 (141 ) 40,0 4,12 2 70
	d)	$\begin{array}{c c} \textbf{Product T300W} \\ \hline \text{Maximum power } (P_{\max}) & 300 \text{ W} \\ \text{Power selection } (\pm 5 \text{ W}) \\ \hline \text{Maximum power voltage } (V_{mp}) & 37 \text{ V} \\ \hline \text{Maximum power current } (I_{mp}) & 8,1 \text{ A} \\ \hline \text{Open circuit voltage } (V_{oc}) & 45,9 \text{ V} \\ \hline \text{Short circuit current } (I_{gc}) & 8,9 \text{ A} \\ \hline \text{Maximum DC system voltage} & 1 000 \text{ V} \\ \hline \pm 3 \% \text{ tolerance on } P_{\max}, I_{sc}, V_{oc} \\ \hline \end{array}$		Fails to meet requirements of IEC 61215-1 5.2.2. Lower edge of power bin is 295 W on nameplate, but is 300 W on datasheet.
	IEC 6121	of a hypothetical conform (a-c) nan 5-1:2021 derived rated values and rm STC rating (d). [IEC 61215-1:20	tolerances in comparison to a hy	•
Severity			NA	



Component	Module		DVFC 4 47							
Defect	Light induced degradation	n in c-Si modules (LID/LeTID	PVFS 1-17vs.01							
Appearance	STC output power, but also sh time of a PV system. It isn't cor	ed degradation in crystalline silicon modules is recognisable mainly as a drop in power, but also short circuit current and open circuit voltage, within the initial life- / system. It isn't correlated with any visual defect or other failure modes. Increasing nity of electroluminescence images (patchwork pattern) can in some cases high- loing degradation process.								
Detection	IV, (EL, IRT)									
Origin	Two different light induced degradation effects are known: LID (light induced degradation) and LeTID (light and elevated temperature induced degradation). Both degradation modes occur at cell level, but the physical mechanism staying behind them are different. The first is related to the concentration of boron and oxygen in the cells, whereas the second one is probably correlated to the concentration of hydrogen in the cell, but the mechanisms are still not fully understood. Mainly p-type multi and mono crystalline silicon modules are affected. High-efficiency cell technologies that use n-type wafers, such as n-type PERC, HJT, or n-PERT seem to be much less or not at all concerned by these two degradation effects. LID occurs only within the first days of exposure to the sun and is limited to 1-3%, whereas LeTID is in a more severe and long-term light induced degradation mechanism. LeTID was observed for the first time with the introduction of PERC modules on the market. The degradation can reach up to 10% and sum-up with the LID loss. It occurs only at elevated temperatures above 50 °C. The speed with which the degradation occurs depends on the average module temperature and is therefore strongly site dependent. The time frame in which it occurs is in the order of magnitude of years. Once the full degradation is reached the modules can regenerate, recovering the lost power. This process is however very slow and also climate dependent. The lost power may even not recover over the typically expected 25-year lifetime of a module. There exist approaches of accelerated regeneration of LeTID-sensitive modules in the field, but they are not very user-friendly. Over the last years always more manufacturers adapted their cell production process to stabilise the cells in-line. Different industrial approaches exist for the mitigation of LeTID and depending on the methodology the degradation rates, even if reduced, can differ from one manufacturer to the other and range from 1-4%.									
	Production	Installation	Operation $\square$							
Impact	yield and financial return. An use the energy yield predictions as because it is generally less so labelling the modules and defirate and the difficulty to predict warranties and system owners laboratory. Serious LID above IR camera, it happened mainly	y problems, but it has a negative nder-estimation of the initial degrand investor expectations. LID is evere and it is taken into accourning the first year warranty, where the trend over time is much made in the sensitivity of PV modules 10% degradation may result in heavy to the cells produced when PE manufacturing process was availed.	radation has a direct impact on less critical for the investors, at by the manufacturers when reas a high LeTID degradation here critical for manufacturers' to LeTID can be tested in the otspot and can be detected by ERC were just commercialized							
	Safety:	Performance: -2	3							
Mitigation	Corrective actions	`	Preventive actions (optional)							
	Confirm underperformance through an accredited PV test laboratory. Claim for missing power.	ify the use of LeTID stable cells by module manufacturer.	Request test reports with % power loss for realistic estimations. Stipulate a contractual agreement on tolerated loss. Test individual modules. Verify BOM (cell type).							

Component	Module					DVEC 4 49 or				
Defect	Insulation	Insulation failure PVFS 1-18vs.01								
Appearance	world) ar measure humid/we can pote or in the tected by	A module with bad insulation between its current carrying parts and the frame (or the outside world) are not directly visible by eye. An unequivocally detection is only possible through a measurement of the insulation resistance of the module under dry (≥40 Mohm/m²) or better humid/wet conditions. It can be sometimes deduced by the presence of visual defects which can potentially lead to insulation problems. Under certain circumstances like after a rain fall or in the early morning when the PV modules are covered by dew, this kind of defect is detected by the inverter (low insulation fault) or the inverter is switching off when the resistance value falls below a certain limit.								
Detection	INS, (MC	DN)								
Origin	module, of the use of the install operation cess close Modules surance of an insular	Insulation failures can have different causes. It can occur in the design/production phase of a module, due to solar cells too closely positioned to the frame or to material weaknesses like the use of inadequate encapsulation or backsheet materials or a poor lamination process. In the installation phase it can be caused by mechanical damages of the module, whereas in the operational phase it is generally caused by catastrophic events or due to a delamination process close to the edge of the module or water ingress or condensation in the junction box. Modules with failed or skipped insulation test in production due to an insufficient quality assurance could be also the origin of the problem. Various module failures are at the origin of an insulation failure: backsheet and encapsulant delamination, backsheet damages, burn marks, glass breakage.								
	Production	on 🔲	Installatio	n 🔲	Oper	ation				
Impact	inverter fa a safety h parts of t	ailure occurs. The pre nazard exposing perso	sence of ar	n electrical leaka tential electric sh	ge current ock hazard	erformance loss, until an to the frame can become l. Touching non-insulated of safety gear and safe				
	Safety:	<u>e</u>		Performance:	1 2 3 4	5				
Mitigation	Correctiv	e actions	Preventive actions (recommended)		Preve (option	entive actions onal)				
	risk or a single replace tions sho tor the single placed midividual modules single lation and	with a direct safety severity of 5 should ced. Regular inspeculd be done to monitatus of the not reodules. In case of inmodule testing all which failed the insud/or wet-leakage test e replaced.	certification and BOM, commissioning of system with IRT, ground fault detection by inverter or other devices at all time.							

Component Defect	Module Hot-spot	(thermal patterns	s)			PVFS 1	I-19vs.01			
Appearance	deviates from such as extended	A hot-spot is a thermal abnormality such as a local overheating or a thermal pattern which deviates from the normal behaviour of a module. It can be detected only by imaging techniques such as e.g. infrared thermography. Hot spots are not visible by the naked eye until they lead to irreversible hot-spot damages like e.g. local <b>yellowing</b> , <b>burn marks</b> , <b>glass</b> or <b>cell breakage</b> . The position, size, intensity and pattern of the hot-spot/s depends on the origin and progress of the failure, but also under which conditions the module is operating (shading, load and irradiance level). A temperature gradient of smaller than 10 K is considered as normal and is not a hot spot or thermal abnormality.								
Detection	IRT, (VI)									
Origin	crack and der joints, production reverse bia is high eno of solder, the effects	A hot spot may be caused by shading, soiling, severe cell mismatch, damaged cells (e.g. cell crack and shunted cells), glass breakage, poor electrical connections (e.g. bad or broken solder joints, short circuits, cell interconnect ribbon failures), or low quality solar cell or module production. When such a condition occurs, the affected cell or group of cells is forced into reverse bias and will dissipate power, which can cause overheating. If the power dissipation is high enough or localised enough, the reverse biased cell(s) can overheat resulting in melting of solder, deterioration of the encapsulant and/or backsheet and glass breakage. To reduce the effects of hot spots bypass diodes are connected in parallel to the cells. Well-dimensioned and correctly working bypass diodes helps in reducing hot spot damages from occurring.								
	Production		Installatio	n 🔲		Operation				
Impact	module prodo not indian insignif vated bypato a reduction when more warmer ce or when it unproblem gradients a compound increase in plant if the tained at a bird dropp later stage	do not always lead oduction, thermal about a special qualiticant power loss. Poss diode leads to a ration of the total mode modules are affectlls. Module safety is leads to a fire. A teratic if it is not increated by the same above 20 K are expensed expensed and the same and the suitable frequency, ings or power mismit might be difficult total and cleaning or main	onormalities by issue. Wower reduce minimized power ted. Very haffected when perature of esting during ent are expended. If I high temperature of the evaluate was evaluate wa	s of less than 1 lost of the time stion becomes cower output of a output. The irresponding losses cannen the overhead of the operation ause power lossed during the operation of the operation of the operation of the operatures of some long time which whether the dar	0% of s module signification occurrent of the sses; in the operation of the sses; in the operation of the special systems of the operation of	the recorded modules with a single cant when a perreceted solar cell son system level when PID is the auses critical module and to module with the properties of the propertie	odules usually hot cell have manently acti- string and thus is only visible e origin of the dule damages considered as Temperature to the PV power and and mainty occur due to damage. At a			
	Safety:	<b>•</b> •		Performance:	1	2 3 4 5				
Mitigation	Corrective	actions	Preventiv (recomm			Preventive actio (optional)	ns			
	risk or a so be replace more than thermal a reason for should be spective	with a direct safety everity of 5 should ed or repaired. If 10% modules show abnormalities, the or that behaviour evaluated and re- corrective actions implemented.	Commiss with IRT.	ioning of sy	/stem	Regular system	inspections.			

EXAMPLES (pa	PVF	<b>6 1-19</b> vs.01				
Pattern	Description	Origin	Performance	Remarks	Safety	Power
	One module warmer than others		Module nor- mally fully func- tional	Check wiring		5
	•	Short circuited (SC) or open sub-string - Bypass diode SC, or - Internal SC	_	May have burned spot at the module	f	5
	Single cells are warmer, not any pattern (patchwork pattern) is recog- nized			Check wiring		(see PVFS 1-15)
	•	degradation	and <i>FF</i> reduced. Low light performance	grounding conditions - recovery		(see PVFS 1-10)
	One cell clearly warmer than the others	- Shadowing effects - Defect cell - Delaminated cell	Power decrease not necessarily permanent, e.g. shadowing leaf or lichen	needed, cleaning (cell mismatch) or		1 2 3 4 5 (see also PVFS 1- 1, 1-3, 3-3)
	Part of a cell is warmer	- Broken cell - Disconnected string interconnect	Drastic power reduction, <i>FF</i> reduction		f	(see also PVFS 1-1, 1-7, 1-9)
	Pointed heating		•	after detailed vis- ual inspection of the cell possible	•	(see also PVFS 1-1, 1-7, 1-9)

Overview of typical IR image patterns observed in outdoor measuerments. [Köntges14]

open-circuit by-

pass diode

or

protection rod

missing

Sub-string with Massive Isc and May cause severe

fire hazard when

hot spot is in this

sub-string

is

(see also PVFS 1-

15, 3-3)

power reduction

when part of this

sub-string

shaded

Sub-string part re-

than others when

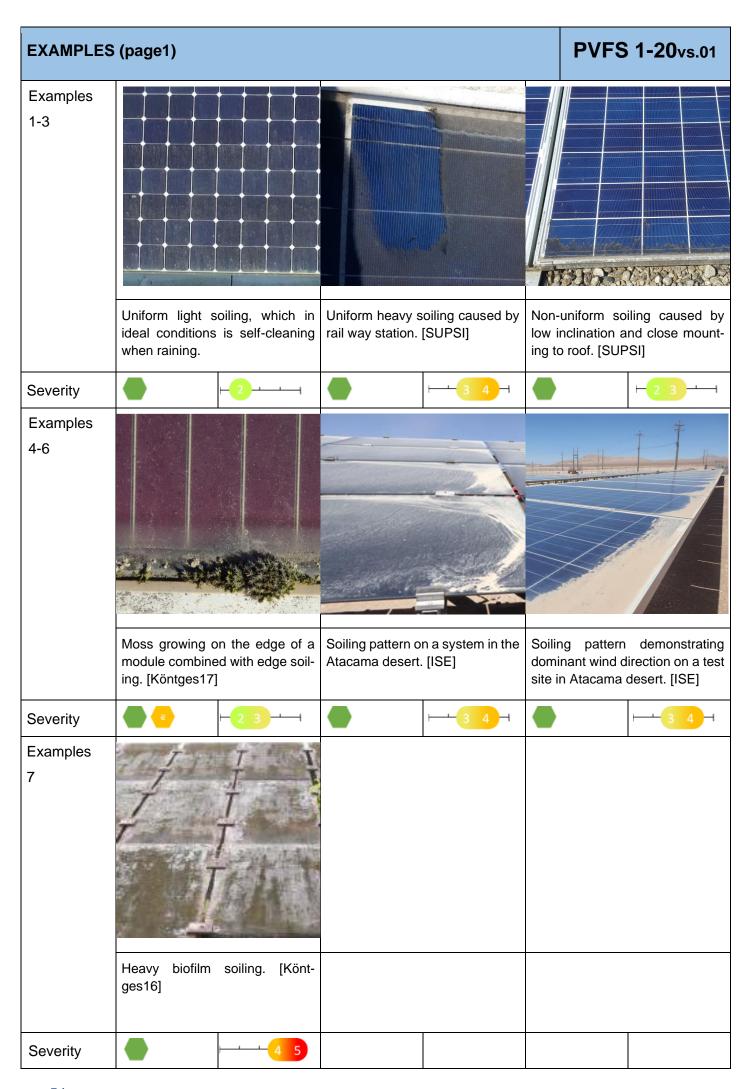
equally shaded

hotter

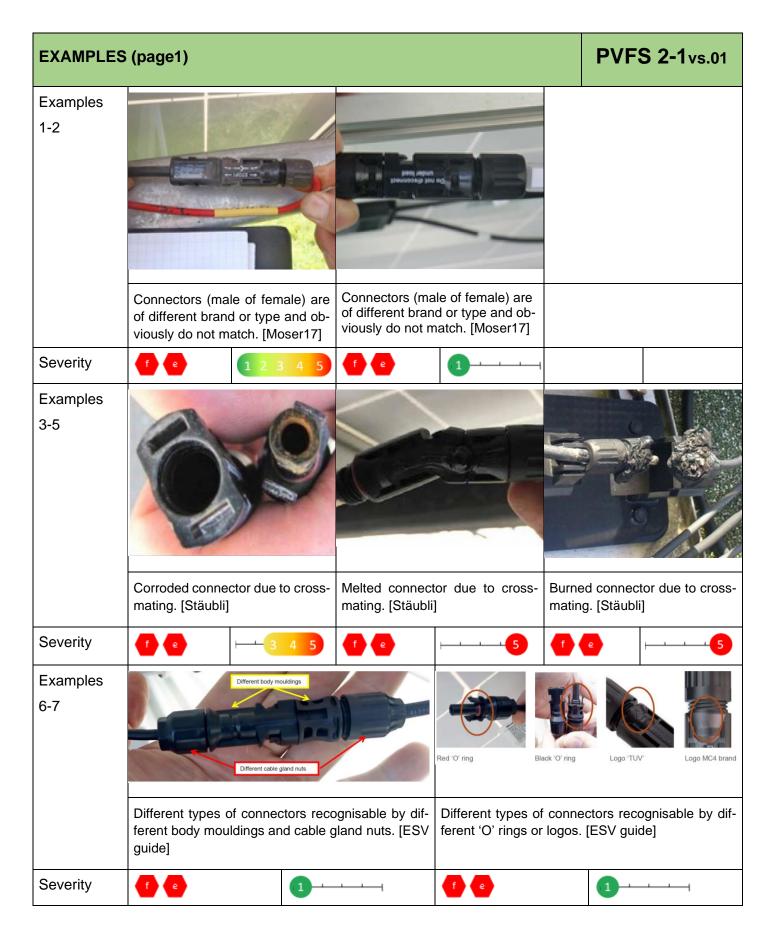
markably

dashed: shaded area

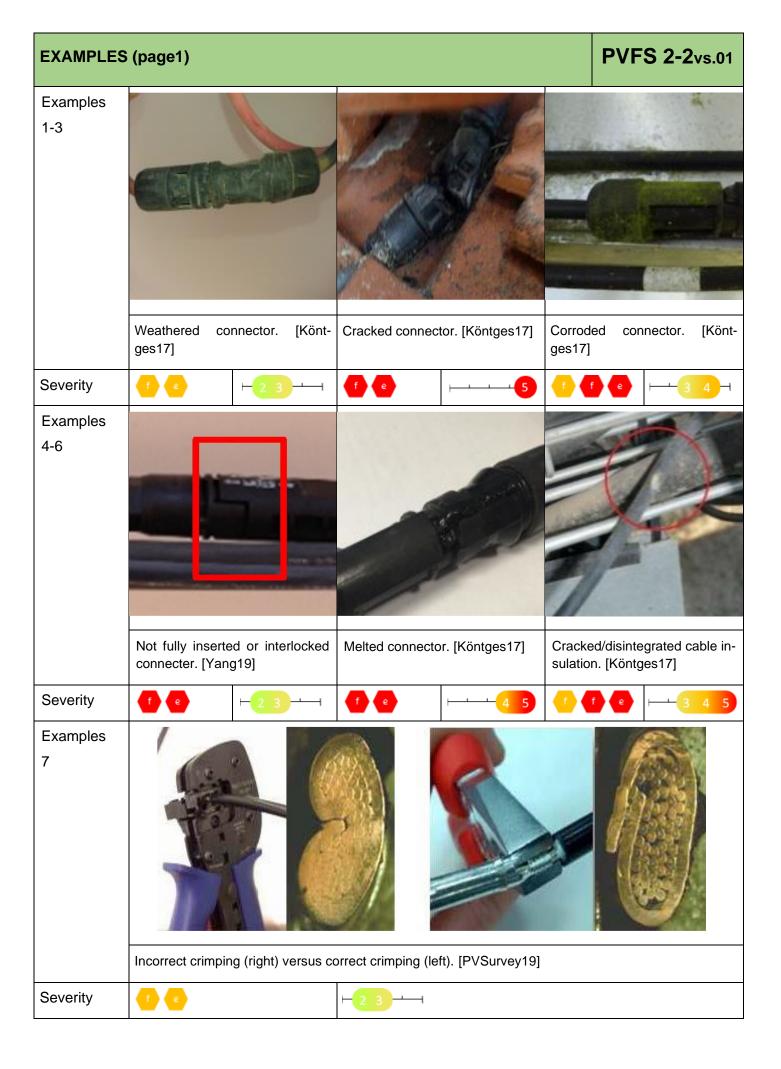
Component Defect	Module Soiling					PVF	FS 1-20vs.01	
Appearance	Soiling is visible as a module. The depositio ence of hot-spots caus	n can be u	niform o	r non-uniform an	d vary	/ in thickness	s. Due to the pres-	
Detection	VI, (IRT, MON)							
Origin	Soiling of PV modules can have various origins such as dust accumulation, air pollution, bird droppings or growth of moss, lichens or algae. It can be due to natural sources, as sand in desert areas, seasonal pollen or volcanic emissions, or due to human activities, as near minning, industry, high ways, railways, urban or agricultural surroundings. The soiling level and its persistence over time depends on the exposure time, the chemical composition and particle size as well as the local climate conditions. Whereas rainfalls and wind can lead to a natural cleaning of modules, humidity can have a contrary effect by increasing adhesion and cementation of dust on the module. The module design (e.g glass coating, frame, distance of cells from the edge), the orientation (e.g tilt angle, azimuth, landscape/portrait) and mounting conditions (e.g clamps, height above ground, stringing) of the modules plays an important role. Typically soiling increases as tilt angles decreases. The direction of the wind or obstacles can influence the soiling process, leading to non-uniform patterns on system and module level.							
	Production		Installat	ion 🔲		Operation		
Impact	The deposited soiling the solar cells, with a cit is reversible when the yield and financial reteriods and dust, extracted to the extraction of the natural angle) much higher to losses which further in permanently damage (PID), soiling can furthe by cleaning the modulus appropriate to the type ability). The cleaning wind or dew can have in reducing soiling and the type of soiling prewhich do not damage increase transmission.	consequente module in urn. Soiling regions with case of species can learn a PV moduler accelerates or previous formatural cases on the coating the coating and the coating the coating and the coating the module serious and the coating the coating and the coating the module and	tial performs cleaned go is a sign of lossed the year-roperific so deffect during each of the year in the coverning each of the year in the coverning each of the year in the	ormance drop. So d, but it has a new te-specific issues of up to 25% round rain, the ariling sources (e.e. to unfavourable ved. Non-uniformar loss and to how odules affected ongoing degradates excessive soiling specific conditions to account the frect at no cost. In grequency, but and if adequativer, it has to be	oiling egative egative e. In a fare nnual g. railole mon soil t-spot by <b>po</b> tion e e. Chat na far Anti-sut only te clea	is not a real e impact on the impact on the impact on the impact on the impact of the	module failure, as the lifetime energy with seasonal dry modules are not es typically ranges in etc.) and/or conditions (e.g low tilt current mismatch extreme cases can aced degradation in gran be mitigated by and water available such as rain-falls, gs (ASC) can helping is adequate for esses are followed,	
	Safety:	<b>e</b>		Performance:	H	2 3 4 5		
Mitigation	Corrective actions			tive actions mended)		Preventive a (optional)	actions	
	Cleaning by qualified precommended when nue lost because of the energy production is his the cleaning cost. A beclean should be defined	the reve- le missed gher than est time to	ons is reve- issed soiling risk. Cost estimation of the sort to install tion. Installation of soiling sets of the implementation of sort to determine the more sort to determine the mo					



Component Defect	Cables and Interconnect DC connector mismatch	ors			PVFS 2-1vs.01	
Appearance	Combination of male and for (cross-mating) between mod				nanufacturers or types	
Detection	VI, (IRT)					
Origin	There is yet no standard for PV connectors prescribing dimensions and tolerances. Therefore, it is possible to find very similar-looking and even apparently fitting connectors on the market, advertised as 'compatible'. Slight differences in the design of the connector can lead to reduced water and vapour tightness. Problems may also occur due to incompatibilities of materials (chemical incompatibility or different thermal expansion parameters) of the metal contact, gaskets or sealings. Most of the time the mismatch of connectors occurs at the string end where extension cables are used or when connecting an inverter or a string combiner box, which has been delivered with incompatible connectors.					
	Production	Installatio	n 🔲	Operat	tion	
Impact	The interconnection of connerisk of loss of performance ar TR 63225:2019]. The consect arcing and in the worth case flow through the connection only over time with increasir humid weather conditions mixerter or a ground fault. The positioned and are close to flow materials. Often connectors spected during normal visual or even in BIPV). In combination of type of contents of the connector of the	nd defects who defects are a fire. One at all. The page contact resmatching criter risk is fur ammable made at least inspections atton with the	nich cause hazar e.g. contact <b>cor</b> e of the most cor roblems do not r esistance and/or onnectors can a ther increased w aterial such as wo partly installed a (e.g. within profile e unclear compa	rosion, burr mon failure nanifest ther degradation lso lead to a hen the conr coden roof b t position whes, undernea atibility issue	n and environment [IEC nt connectors, electrical is is that no current will inselves right away, but nof the connector/s. At partial failure of the innectors are not properly eams or heat-insulation here they cannot be inth roof parallel modules	
	Safety:		Performance:	1 2 3 4	5	
Mitigation	Corrective actions	Preventiv (recomme		Prever (option	ntive actions (al)	
	All not matching connectors should be replaced.					



Component Defect	Cables and Interconnector  Defect DC connector/cable		PVFS 2-2vs.01					
Appearance		onstrate corrosion. Affected c	tle, broken, cracked or whitened. onnectors show very often over-k is performed.					
Detection	VI, (IRT)							
Origin	nents ( <b>DC</b> connector mismate the connectors are either not in tion, exposure to rain or pollute connectors are not fixed correct allowing the connector to dry couse of low quality material in particular selection of components ble glands, inadequate IP class the cables in the installation procables close to connections,	one of the major causes of damaged connectors are the combination of incompatible components ( <b>DC connector mismatch</b> ), a low quality connector or a bad installation. In the last case the connectors are either not installed according the instructions (e.g. bad crimping or connector, exposure to rain or polluted before installation, installation of damaged connectors) or the connectors are not fixed correctly exposing them over longer times to humidity or dirt without flowing the connector to dry completely. In case of damaged cables the major causes are the se of low quality material in production (e.g. insulation material or cupper wires), an inadequate selection of components within the design phase (e.g. undersized cables, too large cate glands, inadequate IP classification or UV protection) or an improper handling or fixing of the cables in the installation phase (e.g. cable routing over sharp or abrading edges, hanging tables close to connections, overly tight bending, missing or not correctly installed cable lands or exposure to direct UV radiation).						
	Production	Installation	Operation					
Impact	the whole string. The continuit can occur (low insulation fault losses. In the worst case damatric arcs. In many cases, the o	by of the circuit isn't any more its or inverter switch off), lead aged cables or not well-connectonnectors and cables are mu	and may lead to the power loss of guaranteed and inverter failures and to partial or complete power cted connectors may cause elected closer to flammable material an the PV module laminate, in-					
	Safety: f e f e	Performance:	2 3 4 5					
Mitigation	Corrective actions	Preventive actions (recommended)	- Preventive actions (optional)					
	Components constituting a direct safety risk should be replaced. Regular inspections should be done to monitor the status of the not replaced components.  Protection of connectors and cables from humidity during installation. Use of adequate crimping tools. Installation are substituted by the staller, perform regular tem inspections.							



EXAMPLES	(page2)			PVFS 2-2vs.01
Examples 8-10				
	Burned connector. [Köntges17]	Corroded Cable. [Köntges17]	Animal ges17]	bite on cable. [Könt-
Severity	<b>f e  5</b>	f e 123	<b>□ 【</b>	e 3 4 5

Component Defect	Cables and Interconnectors Insulation failure  PVFS 2-3vs.01							
Appearance	A bad isolation of cables is not always visible by eye. An unequivocally detection is only possible through the measurement of the insulation resistance under dry or humid/wet conditions. It can be sometimes deduced by the presence of degraded or damaged cables and/or connectors. Under certain circumstances like after a rain fall or in the early morning when the cables or connectors are exposed to humidity, this kind of defect can lead to inverter failures (low insulation fault or inverter switch off).							
Detection	VI, (INS, MON)							
Origin		solation failures occurs as a result of a short-circuit. It is usually the result of a combination of numidity and damaged or degraded DC cables or connectors.						
	Production	Installatio	n 🔲	Operat	ion 🔲			
Impact	A low insulation resistance du loss itself, until an inverter failu voltages in the conducting part hazard. Touching of non-insul gear and safe measuring instricause electric arcs and initiate	re occurs. s of the sys ated parts uments. In	An isolation fault ca tem potentially exp may cause severe	an howeve osing perse injury, wi	r cause potentially fatal ons to an electric shock thout the use of safety			
	Safety: ( e f e		Performance:	2 3 4	5			
Mitigation	Corrective actions	Preventiv (recomme		Preven (option	tive actions al)			
	Cables or connectors constituting a direct safety risk should be replaced. Regular inspections should be done to monitor the status of the not replaced components.	verter or other devices at all time.		_	r system inspections.			

Component Defect	Cables and Interconnectors Thermal damage in combiner box								
Appearance		Defects appearing in the combiner box as discoloured or burned cable interconnections or fuses. Damaged parts can be found by visual inspection or infrared thermography (IRT).							
Detection	VI, IRT, (	MON)							
Origin	(e.g unde	nermal damages in the combiner box can be due to the selection of inadequate components and underrated fuses or fuse holders), a not proper connection of DC cables (e.g improper re torqueing, missing fuses) or a wrong wiring of the modules/strings in the field or on-roof.							
	Production	on 🔲	Installatio	n 🔲	Operation				
Impact	ors/cable	age is caused by the es. The partial or compectrical shock hazard let oprevent further da	olete therm s and risk c	al damage of the	combiner box lea	ds to performance			
	Safety:	f e m f e	m	Performance:	1 2 3 4 5				
Mitigation	Corrective actions		Preventiv (recomm		Preventive (optional)	actions			
	Replace the components with defect or abnormal temperature.  Use IRT to check the components and connection to find poor connection or defect components.								

EXAMPLES	6 (page1)					FS 2-4vs.01
Examples 1-3	Burned terminal combiner box. [7]	al block of the TUV Rheinland	Improper wire to a fire. [Köntges1	erqueing causes 6]	Connection sh sion. [TUV Rh	now signs of corro-einland
Severity	f e m	<u> </u>	f e m	<b>—</b> 5	f e m	1 2
Examples 4		inals show signs ave melted or heinland]				
Severity	f e m	<u> </u>				

Component Defect	_	Mounting Bad module clamping  PVFS 3-1vs.01							
Appearance	Inadequate	e fastening or dama	ge of the m	odule or frame by	the clamp.				
Detection	VI	/I							
Origin	not followe clamps for glass/glass short and t not being of	ne installation instructions of the module and mounting structure from the manufacturer are of followed. Typical errors at the planning and installation stage are: (a) use of inadequate amps for the selected module and/or mounting structure, e.g. sharp edges damaging ass/glass modules, wrong combination of clamps and modules or mounting structure (b) too nort and too narrow clamps or (c) the positions, kind or number of the clamps on the module of being chosen in accordance with the manufacturer's manual. Other errors are too excessively or insufficiently tightened screws during the mounting phase.							
	Production		Installatio	n 🔲	Operat	ion 🔲			
Impact	of the mod can happe it. Once on and result is posing a the proper	lule to stay in place usen as series effect being a module is detached in series detachment a serious hazard to puty in the vicinity of or cell cracks can detached.	under high ecause the ed, the clant. The deta persons anothe installa	wind or load cond modules share the mp immediately load achment of the mod the risk of dama ation site. Probler	itions. The cone clamps votes fixing for dule/s from aging the resus such as	g system and the ability detachment of modules with the module next to rce on the next module the mounting structure st of the system and/or frame damage, glass e performance and the			
	Safety:	f e m e	m	Performance:	1 2 3 4	5			
Mitigation	Corrective	actions		Preventive actions (recommended)		Preventive actions (optional)			
		with a safety risk rity of 5 should be	Use only compatible clamps (mounting structure/ modules/ clamps) and follow manufacturer mounting instructions. Check local wind and snow loads.		es/ mounting ac- accreding ns. facade	of non-standard ng configurations by an ited test laboratory (eg. mounting), perform system inspections			

EXAMPLES	6 (page1)				PVF	S 3-1vs.01
Examples 1-3						
	Improper installation	on of clamp.	Wrong combina and modules. [M		Glass breakage tight screws. [He also PVFS 1-8)	
Severity		1	f e e	1	f m e m	H2 3 4 H
Examples 4						
	Glass breakage c clamp design. [N also PVFS 1-8)					
Severity	f m e m	H2 3 4 H				

Component Defect	Mounting Inappropriate/defe	Mounting Inappropriate/defect mounting structure  PVFS 3-2vs.01						
Appearance	Mechanical damages or mounting holes) o	` •	•	<b>O</b> /	al defects (	e.g. corrosion of frame		
Detection	VI							
Origin	or snow loads which structure does not co ditions), or if the anch conditions are not co strength, to withstand ities, is not verified. A propriate materials (e vanisation, poor qua- leading to a premature errors (e.g. missing/	ypically, this failure occurs when the mounting structure is not designed to withstand the wind a snow loads which are typical for the site in which the system is installed (e.g. mounting structure does not comply with static calculations, underestimation of the environmental contions), or if the anchorage of the mounting structure to the ground or roof is weak (e.g. ground and and the structure of the mounting structure). The roof trength, to withstand the added load of the PV system and include allowance for O&M actives, is not verified. Another reason for the failure of a mounting structure is the use of inappropriate materials (e.g use of corrosive materials in a corrosive environment, insufficient galaxinisation, poor quality material due to a bad or missing quality assurance in production), adding to a premature degradation or mechanical failure of the mounting structure. Installation trors (e.g. missing/non-original components, excessively or insufficiently tightened screws) and be the origin of a failure of the mounting structure.						
	Production		Installatio	n 🔲	Operat	ion 🔲		
Impact	mounted on it and in this leads to the deta or ground, or roof corest of the system an are to be expected, of ules/strings, glass be junction box) and the important for the inst- fixed on steel structure.	some case achment of all apses, por depending or eakage, he time all all all all all are, espectorrosion views.	ses also the f single moosing a ser coperty in the on the dan cell cracled abour reth two differially in hunwhich freques	e substructure (e.go dules or the whole ious hazard to per ne vicinity of the instance on module leads, back sheet do needed to repair the rent metals in contain or costal area nently happens are	roof insulate mounting sons and the stallation site vel (numbe amages, deep system. tact, for exact, for exact	ntegrity of the modules tion). In the worst case structure from the roof he risk of damaging the e. Performance losses of disconnected modamaged or detached Galvanic corrosion is ample aluminium frame tact of different metals stening screws. Theresostal area.		
	Safety:	m		Performance:	1 2 3 4	5		
Mitigation	Corrective actions		Preventiv (recomme		Preven (option	tive actions al)		
	replaced or repaired. Ing structure/modules) and mounting configurations b					of non-standard ng configurations by an ited test laboratory acade mounting), per-		

### **EXAMPLES** (page1) **PVFS 3-2**vs.01 Examples 1-3 Cracks in mounting structure due to Corrosion due to salt water. [Könt-Screw canal bends due to memechanical stress. [Köntges16] ges16] chanical stress. [Köntges16] Severity Examples 4-6 Undersized mounting structure Undersized mounting structure Bracket fractured due to for local snow load conditions. for local wind conditions. [Inmechanical stress. [Köntges16] [Köntges16] dia13] Severity

Component Defect	Mounting Module sh	nading				PVFS 3-3vs.01				
Appearance	performing strings or b	Depending on the position of the sun (day and time), shading can be seen either by eye when performing a visual inspection, or by comparing monitoring data of unshaded and shaded strings or by running shading simulations. The shade can have different patterns and change/move over the day and season.								
Detection	VI, (MON, II	VI, (MON, IRT)								
Origin	fluences the trees, anten cables, or b can change construction	The choice of the mounting structure and the position in which the modules are mounted in- luences the shading conditions. Shading can be caused by different factors or obstacles e.g rees, antennas, poles, chimneys, satellite dishes, roof or façade protrusions, near buildings, cables, or by self-shading (inter array or row-to-row shading) or soiling. Shading conditions can change over the lifetime of a PV system due to growing vegetation, new constructions or construction elements. It can be distinguished between different types of shades: direct shades hindering the direct light to reach the module or diffuse shades.								
	Production		Installation	n 🔲	Operat	ion $\square$				
Impact	lowers the p systems is l façade syste higher than mitigation m use of mode rithms, strin back contact prolonged s glass breal resulting interest and DC shading cor- caused by the diode and re- The choice	berformance of a Pibetween 1-5%, but ems. Due to series the shaded area. The easures like optimule-level power eleg control) or the uset cells). Shading its shading can lead to kage, arcing or fire to higher degradation planning phase, late optimizers for includitions, but the gase he MPLE device its esult in hot spot or of using them only	V system. cenergy lost connection the final lost issed string ctronics (Mase of shading follow-up et a follow-up et it is usually in achieved the shade of the sh	Typically, the cumuses up to 20-30% of cells and module array and module array and module array to the pose a safety is failures (e.g. burner can result in an the right time to could by these devices efficiency), and the ed cell, which increas where shading	nulative annownulative annownu	to a shading obstacle, hual shading loss of PV bserved for roof top or ower loss is significantly dementation or shading (landscape mounting), cs (MPPT search algogies (e.g half-cut cells, e hot-spots caused by pass diode failures, n of the aging process impact of shading is at its such as micro-invert-se performance under ways exceeds the loss till activates the bypass risk of reliability issues. ould be considered and be done in any case.				
	Safety:	f e m		Performance:	<b>⊢</b> 2 3 4	5				
Mitigation	Corrective a	actions	Preventive (recomme		Preven (option	itive actions al)				
	ules with a safety or severity risk of 5 should be replaced or repaired. Eventual trees or vegetation responsi-  year solar/shade data) is reclaimed size of major shading. Size of shading shading shading shading size of shading shading shading size of shading shading shading shading size of shading sh					led shading loss analy- uld be done which esti- and compares different configurations and g mitigation measures. In regular system in- ons.				

EXAMPLES	(page1)				PVI	FS 3-3vs.01
Examples 1-3						
	Shading by pole design: too close ing objects). [Jah		Shading due to coverage by after struction elemen	rwards build con-	Shading by trochanges du [Moser17]	ee with seasonal e to foliage.
Severity		H2 3 4 H		F5		3 4
Examples 4-6						
	Missing mainte green roof. [SUF		Vertical shading module with 3 [J.Lin]	of a standard bypass diodes.	Shading by ba	lustrade. [J.Lin]
Severity	f e m	<u> </u>		3 4 5		<b>⊢234 ⊣</b>
Examples 7	Continuous sha chimney. [SUPS	ding caused by				
Severity	f e m	3 4 5				

Component Defect	Inverter Overheating  PVFS 4-1vs.0				PVFS 4-1vs.01	
Appearance	The inverter reduces its power or switches off to protect components from overheating (temperature derating). Inverters do not always deliver a corresponding status message "power reduction" or "derating". For this reason, it is recommend to check the inverter behaviour by determining and analysing performance curves (Power vs Irradiance).					
Detection	MON, (IV, IRT)					
Origin	Temperature derating of the inverter can occur for various reasons, e.g. improper installation of the inverter, fan failure, dust blocking heat dissipation or an incorrect programming of the inverters.					
	Production	Installation	on 🔲	Operat	ion 🔲	
Impact	When the monitored components in the inverter reach the maximum operating temperature the inverter shifts its operating point to a lower power. During this process, power is reduce step-by-step. In the extreme case, the inverter switches off completely. As soon as the ten perature of the threatened components falls below the critical value, the inverter returns to the optimal operating point. The partial or complete failure of the inverter leads to performance losses, which will get worse if the problem is not solved. In the worst case inverter will switch off. Inverter overheating do not affect module safety.					
	Safety:		Performance:		5	
Action	Corrective actions		Preventive actions (recommended)		Preventive actions (optional)	
	Once identified the origin of the temperature derating the failure should be repaired. The filters and in general heat dissipation path should be cleared of obstruction.	procedur cooling regular in	Follow the given installation procedure, use of adequate cooling technology, perform regular inspections of the ventilation units.		ring of inverter temper-	

# Examples 1-3 Dust blocking heat dissipation [TUV Rheinland] Severity PVFS 4-1vs.01 PVFS 4-1vs.01

Component Defect	Inverter Incorrect installation PVFS 4-2vs.0			PVFS 4-2vs.01		
Appearance	The inverter must be installed according to the installation instruction. A common failures is the installation near flammable, explosive, corrosive or humid sources. Also the minimum distances to bottom, top or to the sides are not always fulfilled. If the input cables are not fixed properly, increased temperatures can occur at the loose contact point which lead to lower performance or risk of fire. Inverters must always be accessible for operation and maintenance and properly secured to an appropriate base.					
Detection	VI (MON)					
Origin	Violating instruction manual, e.g. installed nearby flammable materials as wood or in di sun light.  Minimum distance to adjacent components not maintained.				ls as wood or in direct	
	Production	Installation	on 🔲	Operat	ion 🗆	
Impact	Incorrect installation of the inverter can cause danger to users and hazardous conditions and can result in <b>overheating</b> of the inverter. The use of the inverter in the presence of flammable vapours or gases can lead to explosions. The inverter housing can become very hot under operation. Follow the instruction to provide gaps from both sides and top for adequate cooling. Direct sunlight on the inverters must be avoided. The inverter must be safely accessible to avoid accidents during maintenance work.					
	Safety:		Performance:	1 2 3 4	. 2 3 4 5	
Action	Corrective actions	Preventi (recomi			Preventive actions (optional)	
	follow the installation procedure.		Follow the given installation procedure, use of adequate cooling technology, perform regular inspections of the ventilation units.		ring of inverter temper-	

## **PVFS 4-2**vs.01 **EXAMPLES** (page1) Examples 1-3 Installation in direct sun light. Inverters are not or difficult ac-Distance to bottom, top or to the [TUV Rheinland] cessible for operation sides too low. [TUV Rheinland] maintenance. [TUV Rheinland] Severity Examples 4-5 Housing not appropriate. [TUV Presence of inflammable mate-Rheinland] rial. [SUPSI] Severity

Component Defect	Inverter Not operating (complete failure)			PVFS 4-3vs.01	
Appearance	If the inverter does not work despite good production conditions, common problems are the lack of restart after grid faults or <b>isolation faults</b> . The inverter may show fault codes to help understanding the problem. This can be observed by checking the display or the data log of the monitoring system. Examples for hardware defects in the inverter are discoloured or burned cable interconnections or fuses. Damaged parts can be found by visual inspection or infrared thermography (IRT).				
Detection	MON, (VI, I-V, VOC)				
Origin	A complete failure of the inverter occurs due one or more malfunctions of single hardware or software component of the inverter or faults due to grounding issues, e.g. high humidity inside the inverter, or a firmware issue.				
	Production	Installation	Operation	on $\square$	
Impact	The complete failure of the inverter leads to significant performance losses and immediate actions must be taken. When the restart does not work or the fault occurs recurrently the origin must be identified in most cases by a service team. Software issues can be solved by updating the firmware for technical reasons or to update the system to new standards/grid technical requirements. While damaged hardware components of central inverters are usually repaired, string inverter are replaced more often for economic reasons. Damaged hardware can cause fire and electric shock hazards and must be repaired by qualified personnel.				
	Safety:	Performance:	3 4	5	
Action	Corrective actions	Preventive actions (recommended)	Prevent (optional	ive actions al)	
	Restart the inverter. Replace the components with defect or abnormal temperature. Update the software.	Use IRT and VOC to check the components and connection to find poor connection or defect components.			

EXAMPLES	6 (page1)		PVFS 4-3vs.01
Examples 1-3	A PRINTING IMPARATE INTERNAL PROPERTY OF THE PRINTING PARK AND PAR	1.00 pr 0.0 mh 1.00 pr 1.00	
	Insulation failure. [TUV Rheinland]	Not operating inverter. [TUV Rheinland]	Damaged hardware component. [Sinclair17]
Severity	e 3 4 5	<b>3</b>	<b>f e</b>



